

Technical documentation



Support & training

TEXAS INSTRUMENTS

ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021

# ADC32RF8x Dual-Channel, 3-GSPS Telecom Receiver and Feedback Devices

# 1 Features

- 14-Bit, Dual-Channel, 3-GSPS ADC
- Noise Floor: –155 dBFS/Hz
- RF Input Supports Up to 4.0 GHz
- Aperture Jitter: 90 f<sub>S</sub>
- Channel Isolation: 95 dB at f<sub>IN</sub> = 1.8 GHz
- Spectral Performance (f<sub>IN</sub> = 900 MHz, -2 dBFS):
  - SNR: 60.1 dBFS
  - SFDR: 66-dBc HD2, HD3
  - SFDR: 76-dBc Worst Spur
- Spectral Performance (f<sub>IN</sub> = 1.85 GHz, -2 dBFS):
  - SNR: 58.9 dBFS
  - SFDR: 67-dBc HD2, HD3
  - SFDR: 76-dBc Worst Spur
- On-Chip Digital Down-Converters:
  - Up to 4 DDCs (Dual-Band Mode)
  - Up to 3 Independent NCOs per DDC
- On-Chip Input Clamp for Overvoltage Protection
- Programmable On-Chip Power Detectors with Alarm Pins for AGC Support
- On-Chip Dither
- On-Chip Input Termination
- Input Full-Scale: 1.35 V<sub>PP</sub>
- Support for Multi-Chip Synchronization
- JESD204B Interface:
  - Subclass 1-Based Deterministic Latency
  - 4 Lanes Per Channel at 12.5 Gbps
- Power Dissipation: 3.2 W/Ch at 3.0 GSPS
- 72-Pin VQFN Package (10 mm × 10 mm)

# 2 Applications

- Multi-Carrier GSM Cellular Infrastructure Base Stations
- Telecommunications Receivers
- DPD Observation Receivers
- Backhaul Receivers
- · RF Repeaters and Distributed Antenna Systems

# **3 Description**

The ADC32RF8x (ADC32RF80 and ADC32RF83) is a 14-bit, 3-GSPS, dual-channel telecom receiver and feedback device family that supports RF sampling with input frequencies up to 4 GHz and beyond. Designed for high signal-to-noise ratio (SNR), the ADC32RF8x family delivers a noise spectral density of -155 dBFS/Hz as well as dynamic range and channel isolation over a large input frequency range. The buffered analog input with on-chip termination provides uniform input impedance across a wide frequency range and minimizes sample-and-hold glitch energy.

Each channel can be connected to a dual-band, digital down-converter (DDC) with up to three independent, 16-bit numerically-controlled oscillators (NCOs) per DDC for phase-coherent frequency hopping. Additionally, the ADC is equipped with frontend peak and RMS power detectors and alarm functions to support external automatic gain control (AGC) algorithms.

The ADC32RF8x supports the JESD204B serial interface with subclass 1-based deterministic latency using data rates up to 12.5 Gbps with up to four lanes per ADC. The device is offered in a 72-pin VQFN package (10 mm × 10 mm) and supports the industrial temperature range ( $-40^{\circ}$ C to +85°C).

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ADC32RF8x	VQFN (72)	10.00 mm × 10.00 mm

 For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Block Diagram



# **Table of Contents**

1 Features1
2 Applications1
3 Description1
4 Revision History2
5 Pin Configuration and Functions
6 Specifications5
6.1 Absolute Maximum Ratings5
6.2 ESD Ratings5
6.3 Recommended Operating Conditions5
6.4 Thermal Information6
6.5 Electrical Characteristics7
6.6 AC Performance Characteristics: f <sub>S</sub> = 2949.12
MSPS8
6.7 AC Performance Characteristics: f <sub>S</sub> = 2457.6
MSPS (Performance Optimized for F + A + D Band) 10
6.8 AC Performance Characteristics: f <sub>S</sub> = 2457.6
MSPS (Performance Optimized for F + A Band)10
6.9 Digital Requirements11
6.10 Timing Requirements11
6.11 Typical Characteristics14
7 Parameter Measurement Information29
7.1 Input Clock Diagram29

8 Detailed Description	30
8.1 Overview	
8.2 Functional Block Diagram	
8.3 Feature Description	
8.4 Device Functional Modes	
8.5 Register Maps	
9 Application and Implementation	
9.1 Application Information	120
9.2 Typical Application	
10 Power Supply Recommendations	
11 Layout	130
11.1 Layout Guidelines	130
11.2 Layout Example	
12 Device and Documentation Support	
12.1 Documentation Support	
12.2 Receiving Notification of Documentation Update	es <mark>13</mark> 1
12.3 Support Resources	
12.4 Trademarks	
12.5 Electrostatic Discharge Caution	
12.6 Glossary	
13 Mechanical, Packaging, and Orderable	
Information	131

# **4 Revision History**

nanges from Revision A (December 2016) to Revision B (January 2018)	Page
Updated the numbering format for tables, figures, and cross-references throughout the docum	nent1
Added RHH package option	1
Changed sync to SYSREF in SYSREFM and SYSREFP pin description in Pin Functions table	
Changed OUTSEL GPIO1 to OUTSEL GPIO4 in register 032h, Power Detector Page	71
Changed OUTSEL GPIO2 to OUTSEL GPIO1 in register 033h, Power Detector Page	71
Changed OUTSEL GPIO4 to OUTSEL GPIO2 in register 035h, Power Detector Page	71
Changed bits 3 to 0 in register 037h, Power Detector Page	71
nanges from Revision * (May 2016) to Revision A (December 2016)	Page
Released to production	1



# **5** Pin Configuration and Functions





Table 5-1. Pin Functions

NAME	NO.	I/O	DESCRIPTION				
INPUT, REFEI	RENCE						
INAM	41		Differential analog input for channel A				
INAP	42						
INBM	14		Differential engles input for shannel D				
INBP	13		Differential analog input for channel B				
СМ	22	0	Common-mode voltage for analog inputs, 1.2 V				

#### ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021



#### Table 5-1. Pin Functions (continued) NAME NO. DESCRIPTION I/O CLOCK, SYNC CLKINM 28 Differential clock input for the analog-to-digital converter (ADC). T This pin has an internal differential $100-\Omega$ termination. CLKINP 27 SYSREEM 34 External SYSREF input. This pin has an internal, differential 100-Ω termination and Т requires external biasing. SYSREFP 33 GPI01 19 GPIO control pin; configured through the SPI. This pin can be configured to be GPIO2 20 either a fast overrange output for channel A and B, a fast detect alarm signal from I/O the peak power detect, or a numerically-controlled oscillator (NCO) control. GPIO3 21 GPIO 4 (pin 63) can also be configured as a single-ended SYNCB input. GPIO4 63 CONTROL, SERIAL RESET 48 Hardware reset; active high. This pin has an internal 20-kΩ pulldown resistor. Т SCLK 6 L Serial interface clock input. This pin has an internal 20-k $\Omega$ pulldown resistor. Serial interface data input. This pin has an internal 20-kΩ pulldown resistor. SDIN SDIN 5 I/O can be data input in 4-wire mode, data input and output in 3 wire-mode. SEN 7 L Serial interface enable. This pin has an internal 20-k $\Omega$ pullup resistor to DVDD. SDOUT 0 11 Serial interface data output in 4-wire mode Power down; active high. This pin can be configured through an SPI register setting PDN 50 Т and can be configured to a fast overrange output channel B through the SPI. This pin has an internal 20-k $\Omega$ pulldown resistor. DATA INTERFACE DA0M 62 DA0P 61 DA1M 59 DA1P 58 0 JESD204B serial data output for channel A DA2M 56 DA2P 55 DA3M 54 DA3P 53 DB0M 65 DB0P 66 DB1M 68 DB1P 69 0 JESD204B serial data output for channel B DB2M 71 DB2P 72 DB3M 1 DB3P 2 Synchronization input for the JESD204B port. This pin has an LVDS or 1.8-V logic SYNCBM 36 Т input, an optional on-chip $100-\Omega$ termination, and is selectable through the SPI. SYNCBP 35 This pin requires external biasing. POWER SUPPLY AVDD19 10, 16, 24, 31, 39, 45 Analog 1.9-V power supply Т 9, 12, 15, 17, 25, 30, AVDD L Analog 1.15-V power supply 38, 40, 43, 44, 46 DVDD 4, 8, 47, 51, 57, 64, 70 L Digital 1.15 V-power supply, including the JESD204B transmitter 3, 18, 23, 26, 29, 32,

37, 49, 52, 60, 67

GND

Ground; shorted to thermal pad inside device

Т



# 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Supply voltage range	AVDD19	-0.3	2.1	
	AVDD	-0.3	1.4	V
	DVDD	-0.3	1.4	
	INAP, INAM and INBP, INBM	-0.3	AVDD19 + 0.3	
Voltage applied to input pins	CLKINP, CLKINM	-0.3	AVDD + 0.6	
	SYSREFP, SYSREFM, SYNCBP, SYNCBM	-0.3	AVDD + 0.6	V
	SCLK, SEN, SDIN, RESET, PDN, GPIO1, GPIO2, GPIO3, GPIO4	-0.2	AVDD19 + 0.2	
Voltage applied to output pins		-0.3	2.2	V
Temperature	Operating free-air, T <sub>A</sub>	-40	85	°C
	Storage, T <sub>stg</sub>	-65	150	

(1) Stresses beyond those listed under Section 6.1 may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Section 6.3. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1000	V
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltage <sup>(2)</sup>	AVDD19	1.8	1.9	2.0	
	AVDD	1.1	1.15	1.25	V
	DVDD	1.1	1.15	1.2	
Temperature	Operating free-air, T <sub>A</sub>	-40		85	°C
	Operating junction, T <sub>J</sub>		105 <mark>(1)</mark>	125	C

(1) Prolonged use above this junction temperature may increase the device failure-in-time (FIT) rate.

(2) Always power up the DVDD supply (1.15 V) before the AVDD19 (1.9 V) supply. The AVDD (1.15 V) supply can come up in any order.

#### ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021



#### 6.4 Thermal Information

		ADC3	ADC32RF80		
	THERMAL METRIC <sup>(1)</sup>	RMP (VQFN)	RHH (VQFN)	UNIT	
		72 PINS	72 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	21.8	17.7	°C/W	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	4.4	4.9	°C/W	
R <sub>θJB</sub>	Junction-to-board thermal resistance	2.0	4.1	°C/W	
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.1	0.1	°C/W	
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	2.0	3.9	°C/W	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	0.2	0.2	°C/W	

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.



### **6.5 Electrical Characteristics**

typical values are specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of –40°C to +85°C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
POWER	CONSUMPTION <sup>(4)</sup> (Dual-Channel Oper	ation, Both Channels A and B are A	ctive; Divide-by	-4, Complex	Output M	ode <sup>(3)</sup> )
I <sub>AVDD19</sub>	1.9-V analog supply current	f <sub>S</sub> = 2949.12 MSPS		1777	1989	mA
I <sub>AVDD</sub>	1.15-V analog supply current	f <sub>S</sub> = 2949.12 MSPS		970	1103	mA
I <sub>DVDD</sub>	1.15-V digital supply current	f <sub>S</sub> = 2949.12 MSPS		1785	1955	mA
P <sub>D</sub>	Power dissipation	f <sub>S</sub> = 2949.12 MSPS		6.54	7.07	W
	Global power-down power dissipation			360		mW
ANALOG	INPUTS					
	Resolution			14		Bits
	Differential input full-scale			1.35		V <sub>PP</sub>
V <sub>IC</sub>	Input common-mode voltage			1.2 <sup>(5)</sup>		V
R <sub>IN</sub>	Input resistance	Differential resistance at dc		65		Ω
C <sub>IN</sub>	Input capacitance	Differential capacitance at dc		2		pF
	$V_{CM}$ common-mode voltage output			1.2		V
	Analog input bandwidth (–3-dB point)	ADC driven with 50-Ω source		3200		MHz
ISOLATIO	N					
		f <sub>IN</sub> = 100 MHz		100		
		f <sub>IN</sub> = 900 MHz		99		
	Crosstalk isolation between channel A and channel B <sup>(1)</sup>	f <sub>IN</sub> = 1800 MHz		95		dBc
		f <sub>IN</sub> = 2700 MHz		86		
		f <sub>IN</sub> = 3500 MHz		85		
CLOCK I	NPUT <sup>(2)</sup>				·	
	Input clock frequency		1.5	3		GSPS
	Differential (peak-to-peak) input clock amplitude		0.5	1.5	2.5	V <sub>PP</sub>
	Input clock duty cycle		45%	50%	55%	
	Internal clock biasing			1.0		V
	Internal clock termination (differential)			100		Ω

(1) Crosstalk is measured with a -2-dBFS input signal on aggressor channel and no input on the victim channel.

(2) See Figure 7-1.

(3) Full-scale signal is applied to the analog inputs of all active channels.

(4) See the Section 9.1.4 section for more details.

(5) When used in dc-coupling mode, the common-mode voltage at the analog inputs should be kept within V<sub>CM</sub> ±25 mV for best performance.



# 6.6 AC Performance Characteristics: f<sub>S</sub> = 2949.12 MSPS

typical values specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of –40°C to +85°C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance<sup>(5)</sup>, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN <sup>(3)</sup>	NOM	MAX	UNIT
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		62.6		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		61.1		
SND	Signal to noise ratio	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	55.4	58.9		dBFS
SNR	Signal-to-noise ratio	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		58.2		ubro
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = –2 dBFS		56.8		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		54.1		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = –2 dBFS		154.3		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = –2 dBFS		152.8		
	Noise spectral density	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	147.1	150.6		
NSD	averaged across the Nyquist zone	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = –2 dBFS		149.9		dBFS/Hz
	51	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = –2 dBFS		148.5		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		145.8		
	Small-signal SNR	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -40 dBFS		63.1		dBFS
NF <sup>(1)</sup>	Noise figure	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -40 dBFS		24.7		dB
Signal-to-noise and	f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = –2 dBFS		61.7			
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = –2 dBFS		60.2		
	Signal-to-noise and distortion ratio	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS		58.4		dBFS
SINAD		f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = –2 dBFS		57.6		
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = –2 dBFS		54.8		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		53.6		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = –2 dBFS		10.0		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = –2 dBFS		9.7		
		f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS		9.4		
ENOB	Effective number of bits	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		9.3		Bits
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = –2 dBFS		8.8		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		8.6		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = –2 dBFS		68.0		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = –2 dBFS		66.0		
	Spurious-free dynamic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	58	67.0		
SFDR	range	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = –2 dBFS		64.0		dBc
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = –2 dBFS		58.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		62.0		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		72.0		
		$f_{IN} = 900 \text{ MHz}, A_{OUT} = -2 \text{ dBFS}$		73.0		
	Second-order harmonic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	58	67.0		
HD2 <sup>(4)</sup>	distortion	$f_{IN} = 2100 \text{ MHz}, A_{OUT} = -2 \text{ dBFS}$		64.0		dBc
		f <sub>IN</sub> = 2700 MHz, A <sub>OUT</sub> = –2 dBFS		58.0		
		$f_{IN}$ = 3500 MHz, A <sub>OUT</sub> <sup>(2)</sup> = -3 dBFS with 2-dB gain		62.0		



typical values specified at an ambient temperature of  $25^{\circ}$ C; minimum and maximum values are specified over an ambient temperature range of  $-40^{\circ}$ C to  $+85^{\circ}$ C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance<sup>(5)</sup>, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN <sup>(3)</sup>	NOM	MAX	UNIT
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		68.0		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		66.0		
HD3	Third-order harmonic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	61	73.0		dBc
103	distortion	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		80.0		
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		72.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		65.0		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		85.0		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		81.0		
	Fourth- and fifth-order	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	61	84.0		
HD4, HD5	harmonic distortion	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		84.0		dBc
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		80.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		87.0		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		90.0		
	Interleaving spurs: $f_S / 2 - f_{IN}$ , $f_S / 4 \pm f_{IN}$	f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		77.0		dBc
		f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	69	79.0		
IL spur		f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		76.0		
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		77.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		77.0		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		84.0		
		f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		82.0		dBc
	Interleaving spur for HD2:	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	62	80.0		
HD2 IL	f <sub>S</sub> / 2 – HD2	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		76.0		
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		65.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		77.0		
		f <sub>IN</sub> = 100 MHz, A <sub>OUT</sub> = -2 dBFS		80.0		
	Spurious-free dynamic	f <sub>IN</sub> = 900 MHz, A <sub>OUT</sub> = -2 dBFS		76.0		
Vorst	range (excluding HD2,	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	64	76.0		
spur	HD3, HD4, HD5, and interleaving spurs IL and	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS		75.0		dBc
	HD2 IL)	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		75.0		
		$f_{IN}$ = 3500 MHz, $A_{OUT}$ <sup>(2)</sup> = -3 dBFS with 2-dB gain		71.0		
		$f_{IN1}$ = 1770 MHz, $f_{IN2}$ = 1790 MHz, A <sub>OUT</sub> = -8 dBFS (each tone)		70		
IMD3	Two-tone, third-order intermodulation distortion	$f_{IN1}$ = 1800 MHz, $f_{IN2}$ = 2600 MHz, A <sub>OUT</sub> = -8 dBFS (each tone)		73		dBFS
		$f_{IN1}$ = 3490 MHz, $f_{IN2}$ = 3510 MHz, A <sub>OUT</sub> = -8 dBFS (each tone) with 2-dB gain		67		

(1) The ADC internal resistance =  $65 \Omega$ , the driving source resistance =  $50 \Omega$ .

(2) Output amplitude,  $A_{OUT}$ , refers to the signal amplitude in the ADC digital output that is same as the analog input amplitude,  $A_{IN}$ , except when the digital gain feature is used. If digital gain is G, then  $A_{OUT} = G + A_{IN}$ .

(3) Minimum values are specified at A<sub>OUT</sub> = -3 dBFS.

(4) The minimum value of HD2 is specified by bench characterization.

(5) Performance is shown with DDC bypassed. When DDC is enabled, performance improves by the decimation filtering process.



### 6.7 AC Performance Characteristics: f<sub>S</sub> = 2457.6 MSPS (Performance Optimized for F + A + D Band)

typical values specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of -40°C to +85°C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
SNR	Signal-to-noise ratio	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS		58.5		dBFS
		f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		55.8		UDF3
SFDR	Spurious-free dynamic	$f_{IN}$ = 1850 MHz, $A_{OUT}$ = -2 dBFS		60.0		dBc
SFDR	range	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		57.0		UDC
HD2	Second-order harmonic	$f_{IN}$ = 1850 MHz, $A_{OUT}$ = -2 dBFS		59.0		dBc
ΠUZ	distortion	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		57.0		
HD3	Third-order harmonic distortion	$f_{IN}$ = 1850 MHz, $A_{OUT}$ = -2 dBFS		75.0		dBc
HD3		$f_{IN}$ = 2600 MHz, $A_{OUT}$ = -2 dBFS		65.0		UDC
IL spur	Interleaving spurs:	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS		84.0		
	f <sub>S</sub> / 2 – f <sub>IN</sub> , f <sub>S</sub> / 4 ± f <sub>IN</sub>	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		76.0		dBc
HD2 IL	Interleaving spur for HD2:	$f_{IN}$ = 1850 MHz, $A_{OUT}$ = -2 dBFS		76.0		dBc
	f <sub>S</sub> / 2 – HD2	f <sub>IN</sub> = 2600 MHz, A <sub>OUT</sub> = -2 dBFS		67.0		UDC
IMD3	Two-tone, third-order intermodulation distortion	$f_{IN1}$ = 1800 MHz, $f_{IN2}$ = 2600 MHz, A <sub>OUT</sub> = -8 dBFS (each tone)		67.0		dBFS

(1) F-band = 1880 MHz to 1920 MHz, A-band = 2010 MHz to 2025 MHz, and D-band = 2570 MHz to 2620 MHz.

# 6.8 AC Performance Characteristics: $f_S = 2457.6$ MSPS (Performance Optimized for F + A Band)

typical values specified at an ambient temperature of  $25^{\circ}$ C; minimum and maximum values are specified over an ambient temperature range of  $-40^{\circ}$ C to  $+85^{\circ}$ C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	MIN NOM	MAX	UNIT
SNR	Signal-to-noise ratio	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	58.7		dBFS
SINK		f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS	57.9		UDF3
SFDR	Spurious-free dynamic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	71.0		dBc
SFDR	range	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS	69.0		UDC
HD2	Second-order harmonic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	71.0		dBc
TIDZ	distortion	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS	69.0		
HD3	Third-order harmonic	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	75.0		dBc
TIDS	distortion	$f_{IN}$ = 2100 MHz, $A_{OUT}$ = -2 dBFS	76.0		abc
	Interleaving spurs:	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = -2 dBFS	82.0		
IL spur	f <sub>S</sub> / 2 – f <sub>IN</sub> , f <sub>S</sub> / 4 ± f <sub>IN</sub>	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = –2 dBFS	84.0		dBc
HD2 IL	Interleaving spur for HD2:	f <sub>IN</sub> = 1850 MHz, A <sub>OUT</sub> = –2 dBFS	80.0		dBc
ND2 IL	f <sub>S</sub> / 2 – HD2	f <sub>IN</sub> = 2100 MHz, A <sub>OUT</sub> = -2 dBFS	80.0		ubc

(1) F-band = 1880 MHz to 1920 MHz, A-band = 2010 MHz to 2025 MHz, and D-band = 2570 MHz to 2620 MHz.



#### 6.9 Digital Requirements

typical values are specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of -40°C to +85°C; and chip sampling rate = 2949.12 MSPS, DDC bypassed performance, 50% clock duty cycle, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
DIGITAL	INPUTS (RESET, SCLK, SEN, SDI	N, PDN, GPIO1, GPIO2, GPIO3, GPIO4)				
VIH	High-level input voltage		0.8			V
VIL	Low-level input voltage				0.4	V
I <sub>IH</sub>	High-level input current			50		μA
IIL	Low-level input current			-50		μA
Ci	Input capacitance			4		pF
DIGITAL	OUTPUTS (SDOUT, GPIO1, GPIO2	, GPIO3, GPIO4)				
V <sub>OH</sub>	High-level output voltage		AVDD19- 0.1	AVDD19		V
V <sub>OL</sub>	Low-level output voltage				0.1	V
DIGITAL	INPUTS (SYSREFP and SYSREFM	; SYNCBP and SYNCBM; Requires External	Biasing)			
V <sub>ID</sub>	Differential input voltage		350	450	800	$mV_{PP}$
V <sub>CM</sub>	Input common-mode voltage		1.05	1.2	1.325	V
DIGITAL	OUTPUTS (JESD204B Interface: D	A[3:0], DB[3:0], Meets JESD204B LV-0IF-110	G-SR Standa	rd)		
V <sub>OD</sub>	Output differential voltage			700		$mV_{PP}$
[V <sub>осм</sub> ]	Output common-mode voltage			450		mV
	Transmitter short-circuit current	Transmitter pins shorted to any voltage between –0.25 V and 1.45 V	-100		100	mA
z <sub>os</sub>	Single-ended output impedance			50		Ω
Co	Output capacitance	Output capacitance inside the device, from either output to ground		2		pF

#### 6.10 Timing Requirements

		MIN	NOM	MAX	UNIT
SAMPLE T	MING				
	Aperture delay	250		750	ps
	Aperture delay matching between two channels on the same device		±15		ps
	Aperture delay matching between two devices at the same temperature and supply voltage		±150		ps
	Aperture jitter, clock amplitude = 2 V <sub>PP</sub>		90		f <sub>S</sub>
Latency (1) (3)	Data latency, ADC sample to digital output, DDC block bypassed <sup>(4)</sup> , LMFS = 8224		424		Input clock cycles
	Fast overrange latency, ADC sample to FOVR indication on GPIO pins		70		
t <sub>PD</sub>	Propagation delay time: logic gates and output buffer delay (does not change with $f_{\rm S})$		6		ns
SYSREF TI	MING <sup>(2)</sup>				
t <sub>SU_SYSREF</sub>	SYSREF setup time: referenced to clock rising edge, 2949.12 MSPS	140	70		ps
t <sub>H_SYSREF</sub>	SYSREF hold time: referenced to clock rising edge, 2949.12 MSPS	50	20		ps
	Valid transition window sampling period: t <sub>SU_SYSREF</sub> – t <sub>H_SYSREF</sub> , 2949.12 MSPS	143			ps



typical values are specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of -40°C to +85°C; and chip sampling rate = 2949.12 MSPS, 50% clock duty cycle, DDC-bypassed performance, AVDD19 = 1.9 V, AVDD = 1.15 V, DVDD = 1.15 V, -2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)

		MIN	NOM	MAX	UNIT
JESD (	OUTPUT INTERFACE TIMING				
UI	Unit interval: 12.5 Gbps	80	100	400	ps
	Serial output data rate	2.5	10.0	12.5	Gbps
	Rise, fall times: 1-pF, single-ended load capacitance to ground		60		ps
	Total jitter: BER of 1E-15 and lane rate = 12.5 Gbps		25		%UI
	Random jitter: BER of 1E-15 and lane rate = 12.5 Gbps		0.99		%UI, rms
	Deterministic jitter: BER of 1E-15 and lane rate = 12.5 Gbps		9.1		%UI, pk-pk

- (1) Overall latency = latency + t<sub>PD</sub>.
- (2) Common-mode voltage for the SYSREF input is kept at 1.2 V.
- (3) Latency increases when the DDC modes are used; see Table 8-5.
- (4) For latency in different DDC options, see Table 8-5.



A.  $V_{OCM}$  is not the same as  $V_{ICM}$ . Similarly,  $V_{OD}$  is not the same as  $V_{ID}$ .

#### Figure 6-1. Logic Levels for Digital Inputs and Outputs









#### **6.11 Typical Characteristics**































typical values are specified at an ambient temperature of 25°C; minimum and maximum values are specified over an ambient temperature range of –40°C to +85°C; and ADC sampling rate = 2949.12 MSPS, DDC bypassed performance, 50% clock duty cycle, AVDD19 = 1.9 V, AVDD = DVDD = 1.15 V, –2-dBFS differential input, and 0-dB digital gain (unless otherwise noted)



Copyright © 2021 Texas Instruments Incorporated



























# 7 Parameter Measurement Information

# 7.1 Input Clock Diagram

Figure 7-1 shows the input clock diagram.



Figure 7-1. Input Clock Diagram



# 8 Detailed Description

#### 8.1 Overview

The ADC32RF8x is a dual, 14-bit, 2949.12-MSPS, telecom receiver and feedback device family containing analog-to-digital converters (ADCs) followed by multi-band digital down-converters (DDCs), and a back-end JESD204B digital interface.

The ADCs are preceded by input buffers and on-chip termination to provide a uniform input impedance over a large input frequency range. Furthermore, an internal differential clamping circuit provides first-level protection against overvoltage conditions. Each ADC channel is internally interleaved four times and equipped with background, analog and digital, and interleaving correction.

The on-chip DDC enables single- or dual-band internal processing to pre-select and filter smaller bands of interest and also reduces the digital output data traffic. Each DDC is equipped with up to three independent,

16-bit numerically-controlled oscillators (NCOs) for phase coherent frequency hopping; the NCOs can be controlled through the SPI or GPIO pins. The ADC32RF8x also provides three different power detectors on-chip with alarm outputs in order to support external automatic gain control (AGC) loops.

The processed data are passed into the JESD204B interface where the data are framed, encoded, serialized, and output on one to four lanes per channel, depending on the ADC sampling rate and decimation. The CLKIN, SYSREF, and SYNCB inputs provide the device clock and the SYSREF and SYNCB signals to the JESD204B interface that are used to derive the internal local frame and local multiframe clocks and establish the serial link. All features of the ADC32RF8x are configurable through the SPI.



# 8.2 Functional Block Diagram

Copyright © 2016, Texas Instruments Incorporated



#### 8.3 Feature Description

#### 8.3.1 Analog Inputs

The ADC32RF8x analog signal inputs are designed to be driven differentially. The analog input pins have internal analog buffers that drive the sampling circuit. The ADC32RF8x provides on-chip, differential termination to minimize reflections. The buffer also helps isolate the external driving circuit from the internal switching currents of the sampling circuit, thus resulting in a more constant SFDR performance across input frequencies.

The common-mode voltage of the signal inputs is internally biased to CM using the  $32.5-\Omega$  termination resistors that allow for ac-coupling of the input drive network. Figure 8-1 and Figure 8-2 show SDD11 at the analog inputs from dc to 5 GHz with a 100- $\Omega$  reference impedance.





The input impedance of analog inputs can also be modeled as parallel combination of equivalent resistance and capacitance. Figure 8-3 and Figure 8-4 show how equivalent impedance ( $C_{IN}$  and  $R_{IN}$ ) vary over frequency.



Each input pin (INP, INM) must swing symmetrically between (CM + 0.3375 V) and (CM - 0.3375 V), resulting in a 1.35-V<sub>PP</sub> (default) differential input swing. As shown in Figure 8-5, the input sampling circuit has a 3-dB bandwidth that extends up to approximately 3.2 GHz.



Figure 8-5. Input Bandwidth With a 100-Ω Source Resistance



# 8.3.1.1 Input Clamp Circuit

The ADC32RF8x analog inputs include an internal, differential clamp for overvoltage protection. As shown in Figure 8-6 and Figure 8-7, the clamp triggers for any input signals at approximately 600 mV above the input common-mode voltage, effectively limiting the maximum input signal to approximately 2.4 V<sub>PP</sub>.

When the clamp circuit conducts, the maximum differential current flowing through the circuit (via input pins) must be limited to 20 mA.





#### 8.3.2 Clock Input

The ADC32RF8x sampling clock input includes internal 100- $\Omega$  differential termination along with on-chip biasing. The clock input is recommended to be ac-coupled externally. The input bandwidth of the clock input is approximately 3 GHz; the clock input impedance is shown in the smith chart of Figure 8-8 with a 100- $\Omega$  reference impedance.



Figure 8-8. SDD11 of the Clock Input



The analog-to-digital converter (ADC) aperture jitter is a function of the clock amplitude applied to the pins. The equivalent aperture jitter is shown in Figure 8-9 for input frequencies at a 1-GHz and a 2-GHz input. Depending on the clock frequency, a matching circuit can be designed in order to maximize the clock amplitude.



Figure 8-9. Equivalent Aperture Jitter vs. Input Clock Amplitude

#### 8.3.3 SYSREF Input

The SYSREF signal is a periodic signal that is sampled by the ADC32RF8x device clock and is used to align the boundary of the local multiframe clock inside the data converter. SYSREF is also used to reset critical blocks [such as the clock divider for the interleaved ADCs, numerically-controlled oscillators (NCOs), decimation filters and so forth].

The SYSREF input requires external biasing. Furthermore, SYSREF must be established before the SPI registers are programmed. A programmable delay on the SYSREF input, as shown in Figure 8-10, is available to help with skew adjustment when the sampling clock and SYSREF are not provided from the same source.



Figure 8-10. SYSREF Internal Circuit Diagram



#### 8.3.3.1 Using SYSREF

The ADC32RF8x uses SYSREF information to reset the clock divider, the NCO phase, and the LMFC counter of the JESD interface. The device provides flexibility to provide SYSREF information either from dedicated pins or through SPI register bits. As shown in Figure 8-11, SYSREF is asserted by a low-to-high transition on the SYSREF pins or a 0-to-1 change in the ASSERT SYSREF REG bit when using SPI registers.



#### Figure 8-11. Using SYSREF to Reset the Clock Divider, the NCO, and the LMFC Counter

The ADC32RF8x samples the SYSREF signal on the input clock rising edge. Required setup and hold time are listed in the *Section 6.10* table. The input clock divider gets reset each time that SYSREF is asserted, whereas the NCO phase and the LMFC counter of the JESD interface are reset on each SYSREF assertion after disregarding the first two assertions, as shown in Table 8-1.

SYSREF ASSERTION INDEX	ACTION					
STOREF ASSERTION INDEX	INPUT CLOCK DIVIDER	NCO PHASE	LMFC COUNTER			
1	Gets reset	Does not get reset	Does not get reset			
2	Gets reset	Does not get reset	Does not get reset			
3	Gets reset	Gets reset	Gets reset			
4 and onwards	Gets reset	Gets reset	Gets reset			

#### Table 8-1. Asserting SYSREF

The SYSREF use-cases can be classified broadly into two categories:

1. SYSREF is applied as aperiodic multi-shot pulses.

Figure 8-12 shows a case when only a counted number of pulses are applied as SYSREF to the ADC.


ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021



Alternatively, the SYSREF buffer can be powered down with the PDN SYSREF bit.

# Figure 8-12. SYSREF Used as Aperiodic, Finite Number of Pulses

After the first SYSREF pulse is applied, allow the DLL in the clock path to settle by waiting for the  $t_{DLL}$  time (> 40 µs) before applying the second pulse. During this time, mask the SYSREF going to the input clock divider by setting the MASK CLKDIV SYSREF bit so that the divider output phase remains stable. The NCO phase and LMFC counter are reset on the third SYSREF pulse. After the third SYSREF pulse, the SYSREF going to the NCO and JESD block can be disabled by setting the MASK NCO SYSREF bit to avoid any unwanted resets.



#### 2. SYSREF is applied as a periodic pulse.



#### Figure 8-13 shows how SYSREF can be applied as a continuous periodic waveform.

- A. t<sub>SYSREF</sub> is a period of the SYSREF waveform.
- B. Alternatively, the SYSREF buffer can be powered down using the PDN SYSREF bit.

#### Figure 8-13. SYSREF Used as a Periodic Waveform

After applying the SYSREF signal, DLL must be allowed to lock, and the NCO phase and LMFC counter must be allowed to reset by waiting for at least the  $t_{DLL}$  (40 µs) + 2 ×  $t_{SYSREF}$  time. Then, the SYSREF going to the NCO and JESD can be masked by setting the MASK NCO SYSREF register bit.

#### 8.3.3.2 Frequency of the SYSREF Signal

When SYSREF is a periodic signal, its frequency is required to be a sub-harmonic of the internal local multiframe clock (LMFC) frequency, as described in Equation 1. The LMFC frequency is determined by the selected decimation, frames per multi-frame setting (K), samples per frame (S), and device input clock frequency.

(1)

#### where

• N is an integer value (1, 2, 3, and so forth)

In order for the interleaving correction engine to synchronize properly, the SYSREF frequency must also be a multiple of  $f_S$  / 64. Table 8-2 provides a summary of the valid LMFC clock settings.

Table 6-2 STSREF and LMFC Clock Frequency					
OPERATING MODE	LMFS SETTING	LMFC CLOCK FREQUENCY	SYSREF FRQUENCY		
Decimation	Various	$f_{S}^{(1)} / (D \times S^{(4)} \times K^{(3)})$	$f_{S} / (N \times LCM^{(2)} (64, D^{(5)} \times S \times K))$		

# Table 8-2. . SYSREF and LMFC Clock Frequency

(1) f<sub>S</sub> = sampling (device) clock frequency.

(3) K = number of frames per multi-frame.

(4) S = samples per frame.

(5) D = decimation ratio.

The SYSREF signal is recommended to be a low-frequency signal less than 5 MHz in order to reduce coupling to the signal path both on the printed circuit board (PCB) as well as internal to the device.

<sup>(2)</sup> LCM = least-common multiple.



# Example: f<sub>S</sub> = 2949.12 MSPS, Divide-by-4 (LMFS = 8411), K = 16

SYSREF = 2949.12 MSPS / LCM (4 ,64, 16) = 46.08 MHz / N

Operate SYSREF at 2.88 MHz (effectively divide-by-1024, N = 16)

For proper device operation, disable the SYSREF signal after the JESD synchronization is established.

# 8.3.4 DDC Block

The ADC32RF8x provides a sophisticated on-chip, digital down converter (DDC) block that can be controlled through SPI register settings and the general-purpose input/output (GPIO) pins. The DDC block supports two basic operating modes: receiver (RX) mode with single- or dual-band DDC and wide-bandwidth observation receiver mode.

Note that the ADC32RF80 and ADC32RF83 are identical devices except the fact that the ADC32RF83 offers only single-band DDC option whereas the ADC32RF80 offers both single-band and dual-band DDC options, as shown in Table 8-3.

DD	C OPTION	AVAILABILITY IN DEVICE
Wide-band DDC		ADC32RF80, ADC32RF83
Single-band DDC		ADC32RF80, ADC32RF83
Dua	I-band DDC	ADC32RF80 only

#### Table 8-3. DDC Option Availability

Each ADC channel is followed by two DDC chains consisting of the digital filter along with a complex digital mixer with a 16-bit numerically-controlled oscillator (NCO), as shown in Figure 8-14. The NCOs allow accurate frequency tuning within the Nyquist zone prior to the digital filtering. One DDC chain is intended for supporting a dual-band DDC configuration in receiver mode and the second DDC chain supports the wide-bandwidth output option for the observation configuration. At any given time, either the single-band DDC, the dual-band DDC, or the wideband DDC can be enabled. Furthermore, three different NCO frequencies can be selected on that path and are quickly switched using the SPI or the GPIO pins to enable wide-bandwidth observation in a multi-band application.



Red traces show SYSREF going to the NCO blocks.

#### Figure 8-14. DDC Chains Overview (One ADC Channel Shown)



Additionally, the decimation filter block provides the option to convert the complex output back to real format at twice the decimated, complex output rate. The filter response with a real output is identical to a complex output. The band is centered in the middle of the Nyquist zone (mixed with  $f_{OUT}$  / 4) based on a final output data rate of  $f_{OUT}$ .

### 8.3.4.1 Operating Mode: Receiver

In receiver mode, the DDC block can be configured to single- or dual-band operation, as shown in Figure 8-15. Both DDC chains use the same decimation filter setting and the available options are discussed in the *Section 8.3.4.3* section. The decimation filter setting also directly affects the interface rate and number of lanes of the JESD204B interface.



Red traces show SYSREF going to the NCO blocks.

# Figure 8-15. Decimation Filter Option for Single- or Dual-Band Operation



#### 8.3.4.2 Operating Mode: Wide-Bandwidth Observation Receiver

This mode is intended for using a DDC with a wide bandwidth output, but for multiple bands. This mode uses a single DDC chain where up to three NCOs can be used to perform wide-bandwidth observation in a multi-band environment, as shown in Figure 8-16. The three NCOs can be switched dynamically using either the GPIO pins or an SPI command. All three NCOs operate continuously to ensure phase continuity; however, when the NCO is switched, the output data are invalid until the decimation filters are completely flushed with data from the new band.



Red traces show SYSREF going to the NCO blocks.

#### Figure 8-16. Decimation Filter Implementation for Single-Band and Wide-Bandwidth Mode

#### 8.3.4.3 Decimation Filters

The stop-band rejection of the decimation filters is approximately 90 dB with a pass-band bandwidth of approximately 80%. Table 8-4 gives an overview of the pass-band bandwidth depending on decimation filter setting and ADC sampling rate.

			BAND	BANDWIDTH ADC SAMPLE RATE = N MSPS		ADC SAMPLE RATE = 3 GSPS		
DECIMATION SETTING	NO. OF DDCS AVAILABLE PER CHANNEL	NOMINAL PASSBAND GAIN	3 dB (%)	1 dB (%)	OUTPUT RATE (MSPS) PER BAND	OUTPUT BANDWIDTH (MHz) PER BAND	COMPLEX OUTPUT RATE (MSPS) PER BAND	OUTPUT BANDWIDTH (MHz) PER BAND
Divide-by-4 complex	1	-0.4 dB	90.9	86.8	N / 4 complex	0.4 × N / 2	750	600
Divide-by-6 complex	1	–0.65 dB	90.6	86.1	N / 6 complex	0.4 × N / 3	500	400
Divide-by-8 complex	2	–0.27 dB	91.0	86.8	N / 8 complex	0.4 × N / 4	375	300
Divide-by-9 complex	2	–0.45 dB	90.7	86.3	N / 9 complex	0.4 × N / 4.5	333.3	266.6
Divide-by-10 complex	2	–0.58 dB	90.7	86.3	N / 10 complex	0.4 × N / 5	300	240
Divide-by-12 complex	2	–0.55 dB	90.7	86.4	N / 12 complex	0.4 × N / 6	250	200
Divide-by-16 complex	2	-0.42 dB	90.8	86.4	N / 16 complex	0.4 × N / 8	187.5	150

Table 8-4. Decimation Filter Summary and I	Maximum Available Output Bandwidth
--	------------------------------------

Copyright © 2021 Texas Instruments Incorporated

Table 0.4. Desimation Filter Commune



\ \

			BANDWIDTH ADC		ADC SAMPLE F	ADC SAMPLE RATE = N MSPS		ADC SAMPLE RATE = 3 GSPS	
DECIMATION SETTING	NO. OF DDCS AVAILABLE PER CHANNEL	NOMINAL PASSBAND GAIN	3 dB (%)	1 dB (%)	OUTPUT RATE (MSPS) PER BAND	OUTPUT BANDWIDTH (MHz) PER BAND	COMPLEX OUTPUT RATE (MSPS) PER BAND	OUTPUT BANDWIDTH (MHz) PER BAND	
Divide-by-18 complex	2	–0.83 dB	91.2	87.0	N / 18 complex	0.4 × N / 9	166.6	133	
Divide-by-20 complex	2	–0.91 dB	91.2	87.0	N / 20 complex	0.4 × N / 10	150	120	
Divide-by-24 complex	2	–0.95 db	91.1	86.9	N / 24 complex	0.4 × N / 12	125	100	
Divide-by-32 complex	2	–0.78 dB	91.1	86.8	N / 32 complex	0.4 × N / 16	93.75	75	

nd Maximum Available Ovtavit Dandwidth (a

A dual-band example with a divide-by-8 complex is shown in Figure 8-17.



Figure 8-17. Dual-Band Example

The decimation filter responses normalized to the ADC sampling clock are illustrated in Figure 8-17 to Figure 8-40 and can be interpreted as follows:

Each figure contains the filter pass-band, transition bands, and alias bands, as shown in Figure 8-18. The x-axis in Figure 8-18 shows the offset frequency (after the NCO frequency shift) normalized to the ADC sampling clock frequency.

For example, in the divide-by-4 complex, the output data rate is an  $f_S / 4$  complex with a Nyquist zone of  $f_S / 8$  or 0.125 ×  $f_S$ . The transition band is centered around 0.125 ×  $f_S$  and the alias transition band is centered at 0.375 ×  $f_S$ . The alias bands that alias on top of the wanted signal band are centered at 0.25 ×  $f_S$  and 0.5 ×  $f_S$  (and are colored in red).

The decimation filters of the ADC32RF8x provide greater than 90-dB attenuation for the alias bands.





Figure 8-18. Interpretation of the Decimation Filter Plots



# 8.3.4.3.1 Divide-by-4

Peak-to-peak pass-band ripple: approximately 0.22 dB



#### 8.3.4.3.2 Divide-by-6

Peak-to-peak pass-band ripple: approximately 0.38 dB



#### 8.3.4.3.3 Divide-by-8

Peak-to-peak pass-band ripple: approximately 0.25 dB



#### 8.3.4.3.4 Divide-by-9

Peak-to-peak pass-band ripple: approximately 0.39 dB





#### 8.3.4.3.5 Divide-by-10

Peak-to-peak pass-band ripple: approximately 0.39 dB



### 8.3.4.3.6 Divide-by-12

Peak-to-peak pass-band ripple: approximately 0.36 dB



#### 8.3.4.3.7 Divide-by-16

Peak-to-peak pass-band ripple: approximately 0.29 dB



# 8.3.4.3.8 Divide-by-18

Peak-to-peak pass-band ripple: approximately 0.33 dB



#### 8.3.4.3.9 Divide-by-20

Peak-to-peak pass-band ripple: approximately 0.32 dB



#### 8.3.4.3.10 Divide-by-24

Peak-to-peak pass-band ripple: approximately 0.30 dB

**FEXAS** 

INSTRUMENTS

www.ti.com





#### 8.3.4.3.11 Divide-by-32

Peak-to-peak pass-band ripple: approximately 0.24 dB





#### 8.3.4.3.12 Latency with Decimation Options

Device latency in 12-bit bypass mode (with LMFS = 8224) is 424 clock cycles. When the DDC option is used, latency increases as a result of decimation filters, as described in Table 8-5.

Table 0-0. Latency with unterent Decimation options					
DECIMATION OPTION	TOTAL LATENCY, DEVICE CLOCK CYCLES				
Divide-by-4	516				
Divide-by-6	746				
Divide-by-8	621				
Divide-by-9	763.5				
Divide-by-10	811				
Divide-by-12	897				
Divide-by-16	1045				
Divide-by-18	1164				
Divide-by-20	1256				
Divide-by-24	1443				
Divide-by-32	1773				

# Table 8-5. Latency with different Decimation options

# 8.3.4.4 Digital Multiplexer (MUX)

The ADC32RF8x supports a mode where the output data of the ADC channel A can be routed internally to the digital blocks of both channel A and channel B. The ADC channel B can be powered down as shown in Figure 8-41. In this manner, the ADC32RF8x can be configured as a single-channel ADC with up to four independent DDC chains or two wideband DDC chains. All decimation filters and JESD204B format configurations are identical to the two ADC channel operation.



Figure 8-41. Digital Multiplexer Option

#### 8.3.4.5 Numerically-Controlled Oscillators (NCOs) and Mixers

The ADC32RF8x is equipped with three independent, complex NCOs per ADC channel. The oscillator generates a complex exponential sequence, as shown in Equation 2.

$$x[n] = e^{-j\omega n}$$

where

48 Submit Document Feedback

(2)



• frequency ( $\omega$ ) is specified as a signed number by the 16-bit register setting

The complex exponential sequence is multiplied by the real input from the ADC to mix the desired carrier down to 0 Hz.

Each ADC channel has two DDCs. The first DDC has three NCOs and the second DDC has one NCO. The first DDC can dynamically select one of the three NCOs based on the GPIO pin or SPI selection. In wide-bandwidth mode (lower decimation factors, for example, 4 and 6), there can only be one DDC for each ADC channel. The NCO frequencies can be programmed independently through the DDCx, NCO[4:1], and the MSB and LSB register settings.

The NCO frequency setting is set by the 16-bit register value given by Equation 3:

$$f_{NCO} = \frac{DDCxNCOy \times f_S}{2^{16}}$$
(3)

where

- x = 0, 1
- y = 1 to 4

For example:

If  $f_S$  = 2949.12 MSPS, then the NCO register setting = 38230 (decimal).

Thus, f<sub>NCO</sub> is defined by Equation 4:

$$f_{NCO} = 38230 \times \frac{2949.12 \text{ MSPS}}{2^{16}} = 1720.35 \text{ MHz}$$
(4)

Any register setting changes that occur after the JESD204B interface is operational results in a non-deterministic NCO phase. If a deterministic phase is required, the JESD204B interface must be reinitialized after changing the register setting.

#### 8.3.5 NCO Switching

The first DDC (DDC0) on each ADC channel provides three different NCOs that can be used for phase-coherent frequency hopping. This feature is available in both single-band and dual-band mode, but only affects DDC0.

The NCOs can be switched through an SPI control or by using the GPIO pins with the register configurations shown in Table 8-6 for channel A (50xxh) and channel B (58xxh). The assignment of which GPIO pin to use for INSEL0 and INSEL1 is done based on Table 8-7, using registers 5438h and 5C38h. The NCO selection is done based on the logic selection on the GPIO pins; see Table 8-8 and Figure 8-42.

REGISTER	ADDRESS	DESCRIPTION
NCO CONTROL THROUGH GPIO PINS		
NCO SEL pin	500Fh, 580Fh	Selects the NCO control through the SPI (default) or a GPIO pin.
INSEL0, INSEL1	5438h, 5C38h	Selects which two GPIO pins are used to control the NCO.
NCO CONTROL THROUGH SPI CONTROL		
NCO SEL pin	500Fh, 580Fh	Selects the NCO control through the SPI (default) or a GPIO pin.
NCO SEL	5010h, 5810h	Selects which NCO to use for DDC0.

Table 8-6	. NCO	Register	Configurations
-----------	-------	----------	----------------

#### Table 8-7. GPIO Pin Assignment

INSELx[1:0] (Where x = 0 or 1)	GPIO PIN SELECTED
00	GPIO4
01	GPIO1
10	GPIO3

Copyright © 2021 Texas Instruments Incorporated





Table 8-7. GPIO Pin Assignment (continued
---

INSELx[1:0] (Where x = 0 or 1)	GPIO PIN SELECTED
11	GPIO2

# Table 8-8. NCO Selection

NCO SEL[1]	NCO SEL[0]	NCO SELECTED
0	0	NCO1
0	1	NCO2
1	0	NCO3
1	1	n/a



#### Figure 8-42. NCO Switching from GPIO and SPI

#### 8.3.6 SerDes Transmitter Interface

Each 12.3-Gbps serializer, deserializer (SerDes) LVDS transmitter output requires ac-coupling between the transmitter and receiver. Terminate the differential pair with 100- $\Omega$  resistance (that is, two 50- $\Omega$  resistors) as close to the receiving device as possible to avoid unwanted reflections and signal degradation, as shown in Figure 8-43.



Figure 8-43. External Serial JESD204B Interface Connection



# 8.3.7 Eye Diagrams

Figure 8-44 and Figure 8-45 show the serial output eye diagrams of the ADC32RF8x at 5.0 Gbps and 12 Gbps against the JESD204B mask.



# 8.3.8 Alarm Outputs: Power Detectors for AGC Support

The GPIO pins can be configured as alarm outputs for channels A and B. The ADC32RF8x supports three different power detectors (an absolute peak power detector, crossing detector, and RMS power detector) as well as fast overrange from the ADC. The power detectors operate off the full-rate ADC output prior to the decimation filters.

#### 8.3.8.1 Absolute Peak Power Detector

In this detector mode, the peak is computed over eight samples of the ADC output. Next, the peak for a block of N samples (N × S<sup> $\circ$ </sup>) is computed over a programmable block length and then compared against a threshold to either set or reset the peak detector output (Figure 8-46 and Figure 8-47). There are two sets of thresholds and each set has two thresholds for hysteresis. The programmable DWELL-time counter is used for clearing the block detector alarm output.





# ADC32RF80, ADC32RF83

SBAS774B - MAY 2016 - REVISED DECEMBER 2021





Figure 8-47. Peak Power Detector Timing Diagram

Table 8-9 shows the register configurations required to set up the absolute peak power detector. The detector operates in the  $f_S$  / 8 clock domain; one peak sample is calculated over eight actual samples.

The automatic gain control (AGC) modes can be configured separately for channel A (54xxh) and channel B (5Cxxh), although some registers are common in 54xxh (such as the GPIO pin selection).

REGISTER	ADDRESS	DESCRIPTION
PKDET EN	5400, 5C00h	Enables peak detector
BLKPKDET	5401h, 5402h, 5403h, 5C01h, 5C02h, 5C03h	Sets the block length N of number of samples (S`). Number of actual ADC samples is $8x$ this value: N is 17 bits: 1 to $2^{16}$ .
BLKTHHH, BLKTHHL, BLKTHLH, BLKTHLL	5407h, 5408h, 5409h, 540Ah, 5C07h, 5C08h, 5C09h, 5C0Ah	Sets the different thresholds for the hysteresis function values from 0 to 256 (where 256 is equivalent to the peak amplitude). For example: if BLKTHHH is to $-2$ dBFS from peak, $10^{(-2/20)} \times 256 = 203$ , then set 5407h and 5C07h = CBh.
DWELL	540Bh, 540Ch, 5C0Bh, 5C0Ch	When the computed block peak crosses the upper thresholds BLKTHHH or BLKTHLH, the peak detector output flags are set. In order to be reset, the computed block peak must remain continuously lower than the lower threshold (BLKTHHL or BLKTHLL) for the period specified by the DWELL value. This threshold is 16 bits and is specified in terms of $f_S / 8$ clock cycles.
OUTSEL GPIO[4:1]	5432h, 5433h, 5434h, 5435h	Connects the BLKPKDETH, BLKPKDETL alarms to the GPIO pins; common register.
IODIR	5437h	Selects the direction for the four GPIO pins; common register.
RESET AGC	542Bh, 5C2Bh	After configuration, reset the AGC module to start operation.

# Table 8-9. Registers Required for the Peak Power Detector



#### 8.3.8.2 Crossing Detector

In this detector mode the peak is computed over eight samples of the ADC output. Next, the peak for a block of N samples (N × S') is computed over a programmable block length and then the peak is compared against two sets of programmable thresholds (with hysteresis). The crossing detector counts how many  $f_S$  / 8 clock cycles that the block detector outputs are set high over a programmable time period and compares the counter value against the programmable thresholds. The alarm outputs are updated at the end of the time period, routed to the GPIO pins, and held in that state through the next cycle, as shown in Figure 8-48 and Figure 8-49. Alternatively, a 2-bit format can be used but (because the ADC32RF8x has four GPIO pins available) this feature uses all four pins for a single channel.





Figure 8-49. Crossing Detector Timing Diagram



Table 8-10 shows the register configurations required to set up the crossing detector. The detector operates in the

 $f_S$  / 8 clock domain. The AGC modes can be configured separately for channel A (54xxh) and channel B (5Cxxh), although some registers are common in 54xxh (such as the GPIO pin selection).

REGISTER	ADDRESS	DESCRIPTION
PKDET EN	5400h, 5C00h	Enables peak detector
BLKPKDET	5401h, 5402h, 5403h, 5C01h, 5C02h, 5C03h	Sets the block length N of number of samples (S`). Number of actual ADC samples is 8x this value: N is 17 bits: 1 to $2^{16}$ .
BLKTHHH, BLKTHHL, BLKTHLH, BLKTHLL	5407h, 5408h, 5409h, 540Ah, 5C07h, 5C08h, 5C09h, 5C0Ah	Sets the different thresholds for the hysteresis function values from 0 to 256 (where 256 is equivalent to the peak amplitude). For example: if BLKTHHH is to $-2$ dBFS from peak, $10^{(-2/20)} \times 256 = 203$ , then set 5407h and 5C07h = CBh.
FILTOLPSEL	540Dh, 5C0Dh	Select block detector output or 2-bit output mode as the input to the interrupt identification register (IIR) filter.
TIMECONST	540Eh, 540Fh, 5C0Eh, 5C0Fh	Sets the crossing detector time period for N = 0 to 15 as $2N \times f_S / 8$ clock cycles. The maximum time period is $32768 \times f_S / 8$ clock cycles (approximately $87 \mu s$ at 3 GSPS).
FILOTHH, FILOTHL, FIL1THH, FIL1THL	540Fh-5412h, 5C0Fh-5C12h, 5416h-5419h, 5C16h-5C19h	Comparison thresholds for the crossing detector counter. These thresholds are 16-bit thresholds in 2.14-signed notation. A value of 1 (4000h) corresponds to 100% crossings, a value of 0.125 (0800h) corresponds to 12.5% crossings.
DWELLIIR	541Dh, 541Eh, 5C1Dh, 5C1Eh	DWELL counter for the IIR filter hysteresis.
IIR0 2BIT EN, IIR1 2BIT EN	5413h, 54114h, 5C13h, 5C114h	Enables 2-bit output format for the crossing detector.
OUTSEL GPIO[4:1]	5432h, 5433h, 5434h, 5435h	Connects the IIRPKDET0, IIRPKDET1 alarms to the GPIO pins; common register.
IODIR	5437h	Selects the direction for the four GPIO pins; common register.
RESET AGC	542Bh, 5C2Bh	After configuration, reset the AGC module to start operation.

# Table 8-10. Registers Required for the Crossing Detector Operation



#### 8.3.8.3 RMS Power Detector

In this detector mode the peak power is computed for a block of N samples over a programmable block length and then compared against two sets of programmable thresholds (with hysteresis).

The RMS power detector circuit provides configuration options, as shown in Figure 8-50. The RMS power value (1 or 2 bit) can be output onto the GPIO pins. In 2-bit output mode, two different thresholds are used whereas the 1-bit output provides one threshold together with hysteresis.



Figure 8-50. RMS Power Detector Implementation

Table 8-11 shows the register configurations required to set up the RMS power detector. The detector operates in the  $f_S$  / 8 clock domain. The AGC modes can be configured separately for channel A (54xxh) and channel B (5Cxxh), although some registers are common in 54xxh (such as the GPIO pin selection).

REGISTER	ADDRESS	DESCRIPTION
RMSDET EN	5420h, 5C20h	Enables RMS detector
PWRDETACCU	5421h, 5C21h	Programs the block length to be used for RMS power computation. The block length is defined in terms of $f_S / 8$ clocks. The block length can be programmed as $2^M$ with M = 0 to 16.
PWRDETH, PWRDETL	5422h, 5423h, 5424h, 5425h, 5C22h, 5C23h, 5C24h, 5C25h	The computed average power is compared against these high and low thresholds. One LSB of the thresholds represents $1 / 2^{16}$ . For example: is PWRDETH is set to $-14 \text{ dBFS}$ from peak, $[10^{(-14 / 20)}]^2 \times 2^{16} = 2609$ , then set 5422h, 5423h, 5C22h, 5C23h = 0A31h.
RMS2BIT EN	5427h, 5C27h	Enables 2-bit output format for the RMS detector output.
OUTSEL GPIO[4:1]	5432h, 5433h, 5434h, 5435h	Connects the PWRDET alarms to the GPIO pins; common register.
IODIR	5437h	Selects the direction for the four GPIO pins; common register.
RESET AGC	542Bh, 5C2Bh	After configuration, reset the AGC module to start operation.

Table 8-11, Registers Reg	auired for Usina the RMS	6 Power Detector Feature



# 8.3.8.4 GPIO AGC MUX

The GPIO pins can be used to control the NCO in wideband DDC mode or as alarm outputs for channel A and B. The GPIO pins can be configured through the SPI control to output the alarm from the peak power (1 bit), crossing detector (1 or 2 bit), faster overrange, or the RMS power output, as shown in Figure 8-51.

The programmable output MUX allows connecting any signal (including the NCO control) to any of the four GPIO pins. These pins can be configured as outputs (AGC alarm) or inputs (NCO control) through SPI programming.



OUTSEL GPIO[4:1]

Figure 8-51. GPIO Output MUX Implementation

#### 8.3.9 Power-Down Mode

The ADC32RF8x provides a lot of configurability for the power-down mode. Power-down can be enabled using the PDN pin or the SPI register writes.

#### 8.3.10 ADC Test Pattern

The ADC32RF8x provides several different options to output test patterns instead of the actual output data of the ADC in order to simplify the serial interface and system debug of the JESD204B digital interface link. The output data path is shown in Figure 8-52.



Figure 8-52. Test Pattern Generator Implementation

# 8.3.10.1 Digital Block

The ADC test pattern replaces the actual output data of the ADC. The test patterns listed in Table 8-12 are available when the DDC is enabled and located in register 37h of the decimation filter page. When programmed, the test patterns are output for each converter (M) stream. The number of converter streams per channel increases by 2 when complex (I, Q) output or dual-band DDC is selected. The test patterns can be synchronized for both ADC channels using the SYSREF signal.

Additionally, a 12-bit test pattern is also available.



# Note

The number of converters increases in dual-band DDC mode and with a complex output.

DIT	•	ter 3/h and 38h in Decimation Filter Page)	
BIT	NAME	DEFAULT	DESCRIPTION
Address 37h, 38h (bits 7-0)	TEST PATTERN DDC1 I-DATA, TEST PATTERN DDC1 Q-DATA, TEST PATTERN DDC2 I-DATA, TEST PATTERN DDC2 Q-DATA,	0000	Test pattern outputs onl and Q stream of channel A and B when DDC option is chosen. 0000 = Normal operation using ADC output data 0001 = Outputs all 0s 0010 = Outputs all 1s 0011 = Outputs toggle pattern: output data are an alternating sequence of 10101010101010 and 01010101010101 0100 = Output digital ramp: output data increment by one LSB every clock cycle from code 0 to 65535 0110 = Single pattern: output data are a custom pattern 1 (75h and 76h) 0111 Double pattern: output data alternate between custom pattern 1 and custom pattern 2 1000 = Deskew pattern: output data are FFFFh

# Table 8-12. Test Pattern Options (Register 37h and 38h in Decimation Filter Page

# 8.3.10.2 Transport Layer

The transport layer maps the ADC output data into 8-bit octets and constructs the JESD204B frames using the LMFS parameters. Tail bits or 0's are added when needed. Alternatively, the JESD204B long transport layer test pattern can be substituted instead of the ADC data with the JESD frame, as shown in Table 8-13.

#### Table 8-13. Transport Layer Test Mode EN (Register 01h)

BIT	NAME	DEFAULT	DESCRIPTION
4	TESTMODE EN	0	Generates long transport layer test pattern mode according to section 5.1.6.3 of the JESD204B specification. 0 = Test mode disabled 1 = Test mode disabled

#### 8.3.10.3 Link Layer

The link layer contains the scrambler and the 8b, 10b encoding of any data passed on from the transport layer. Additionally, the link layer also handles the initial lane alignment sequence that can be manually restarted.

The link layer test patterns are intended for testing the quality of the link (jitter testing and so forth). The test patterns do not pass through the 8b, 10b encoder and contain the options listed in Table 8-14.

BIT	NAME	DEFAULT	DESCRIPTION
7-5	LINK LAYER TESTMODE	000	Generates a pattern according to section 5.3.3.8.2 of the JESD204B document. 000 = Normal ADC data 001 = D21.5 (high-frequency jitter pattern) 010 = K28.5 (mixed-frequency jitter pattern) 011 = Repeat the initial lane alignment (generates a K28.5 character and repeats lane alignment sequences continuously) 100 = 12-octet random pattern (RPAT) jitter pattern

#### Table 8-14. Link Layer Test Mode (Register 03h)

Furthermore, a 2<sup>15</sup> pseudo-random binary sequence (PRBS) can be enabled by setting up a custom test pattern (AAAAh) in the ADC section and running AAAAh through the 8b, 10b encoder with scrambling enabled.

Copyright © 2021 Texas Instruments Incorporated



# 8.4 Device Functional Modes

## 8.4.1 Device Configuration

The ADC32RF8x can be configured using a serial programming interface, as described in the Section 8.4.3 section. In addition, the device has one dedicated parallel pin (PDN) for controlling the power-down modes.

#### 8.4.2 JESD204B Interface

The ADC32RF8x supports device subclass 1 with a maximum output data rate of 12.5 Gbps for each serial transmitter.

An external SYSREF signal is used to align all internal clock phases and the local multiframe clock to a specific sampling clock edge. This alignment allows synchronization of multiple devices in a system and minimizes timing and alignment uncertainty. The SYNCB input is used to control the JESD204B SerDes blocks, as shown in Figure 8-53.

Depending on the ADC sampling rate, the JESD204B output interface can be operated with one, two, or four lanes per ADC channel. The JESD204B setup and configuration of the frame assembly parameters is controlled through the SPI interface.



Copyright © 2016, Texas Instruments Incorporated

Figure 8-53. JESD Signal Overview

The JESD204B transmitter block consists of the transport layer, the data scrambler, and the link layer, as shown in Figure 8-54. The transport layer maps the ADC output data into the selected JESD204B frame data format and manages if the ADC output data or test patterns are transmitted. The link layer performs the 8b, 10b data encoding as well as the synchronization and initial lane alignment using the SYNC input signal. Optionally, data from the transport layer can be scrambled.



Copyright © 2016, Texas Instruments Incorporated





# 8.4.2.1 JESD204B Initial Lane Alignment (ILA)

The receiving device starts the initial lane alignment process by deasserting the SYNCB signal. The SYNCB signal can be issued using the SYNCB input pins or by setting the proper SPI bits. When a logic low is detected on the SYNCB input, the ADC32RF8x starts transmitting comma (K28.5) characters to establish the code group synchronization, as shown in Figure 8-55.

When synchronization completes, the receiving device reasserts the SYNCB signal and the ADC32RF8x starts the initial lane alignment sequence with the next local multiframe clock boundary. The ADC32RF8x transmits four multiframes, each containing K frames (K is SPI programmable). Each of the multiframes contains the frame start and end symbols. The second multiframe also contains the JESD204 link configuration data.



Figure 8-55. JESD Internal Timing Information

# 8.4.2.2 JESD204B Frame Assembly

The JESD204B standard defines the following parameters:

- · F is the number of octets per frame clock period
- L is the number of lanes per link
- M is the number of converters for the device
- S is the number of samples per frame



# 8.4.2.3 JESD204B Frame Assembly with Decimation (Single-Band DDC): Complex Output

Table 8-15 lists the available JESD204B interface formats and valid ranges for the ADC32RF8x with decimation (single-band DDC) when using a complex output format. The ranges are limited by the SerDes line rate and the maximum ADC sample frequency. The sample alignment on the different lanes is shown in Table 8-16.

DECIMATIO N SETTING (Complex)	NUMBER OF ACTIVE DDCS	L	М	F	S	PLL MODE	JESD MODE0	JESD MODE1	JESD MODE2	RATIO [fSerDes / f CLK (Gbps/ GSPS)]
Divide-by-4	1per channel	8	4	1	1	20X	1	1	0	2.5
		8	4	2	2	20X	1	0	0	
		4	4	2	1	40X	0	0	1	5
	4	4	4	2	40X	2	0	0		
Divide-by-6	1per channel	8	4	1	1	20X	1	1	0	1.67
		8	4	2	2	20X	1	0	0	
		4	4	2	1	40X	0	0	1	3.33
	4	4	4	2	40X	2	0	0	1	
Divide-by-8 1per channel	4	4	2	1	20X	1	0	0	2.5	
		2	4	4	1	40X	2	0	0	5
Divide-by-9	1per channel	4	4	2	1	20X	1	0	0	2.22
		2	4	4	1	40X	2	0	0	4.44
Divide-by-10	1per channel	4	4	2	1	20X	1	0	0	2
		2	4	4	1	40X	2	0	0	4
Divide-by-12	1per channel	4	4	2	1	20X	1	0	0	1.67
		2	4	4	1	40X	2	0	0	3.33
Divide-by-16	1per channel	4	4	2	1	20X	1	0	0	1.25
		2	4	4	1	40X	2	0	0	2.5
Divide-by-18	1per channel	4	4	2	1	20X	1	0	0	1.11
-		2	4	4	1	40X	2	0	0	2.22
Divide-by-20	1per channel	4	4	2	1	20X	1	0	0	1
		2	4	4	1	40X	2	0	0	2
Divide-by-24	1per channel	2	4	4	1	20X	1	0	0	1.67
Divide-by-32	1per channel	2	4	4	1	40X	2	0	0	1.25

# Table 8-15. JESD Mode Options: Single-Band Complex Output

#### Table 8-16. JESD Sample Lane Alignments: Single-Band Complex Output

OUTPUT LANE	LMFS = 8411	LMFS	= 8422	LMFS =	4421 20x	LMFS = 4421 40x		LMFS = 4442			LMFS = 2441				
DA0	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [7:0]	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [7:0]										
DA1	Al <sub>0</sub> [7:0]	Al <sub>1</sub> [15:8]	Al <sub>1</sub> [7:0]	AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [7:0]	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [7:0]	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [7:0]	Al <sub>1</sub> [15:8]	Al <sub>1</sub> [7:0]	Al <sub>0</sub> [15:8]	Al <sub>0</sub> [7:0]	AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [7:0]
DA2	AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [7:0]			AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [7:0]	AQ <sub>0</sub> [15:8]	AQ <sub>0</sub> [7:0]	AQ <sub>1</sub> [15:8]	AQ <sub>1</sub> [7:0]				
DA3	AQ <sub>0</sub> [7:0]	AQ <sub>1</sub> [15:8]	AQ <sub>1</sub> [7:0]												
DB0	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [7:0]	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [7:0]										
DB1	Bl <sub>0</sub> [7:0]	Bl <sub>1</sub> [15:8]	Bl <sub>1</sub> [7:0]	BQ <sub>0</sub> [15:8]	BQ <sub>0</sub> [7:0]	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [7:0]	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [7:0]	Bl <sub>1</sub> [15:8]	Bl <sub>1</sub> [7:0]	Bl <sub>0</sub> [15:8]	Bl <sub>0</sub> [7:0]	BQ <sub>0</sub> [15:8]	BQ <sub>0</sub> [7:0]
DB2	BQ <sub>0</sub> [15:8]	BQ <sub>0</sub> [15:8	BQ <sub>0</sub> [7:0]			BQ <sub>0</sub> [15:8]	BQ <sub>0</sub> [7:0]	BQ <sub>0</sub> [15:8]	BQ <sub>0</sub> [7:0]	BQ <sub>1</sub> [15:8]	BQ <sub>1</sub> [7:0]				
DB3	BQ <sub>0</sub> [7:0]	BQ <sub>1</sub> [15:8]	BQ <sub>1</sub> [7:0]												



# 8.4.2.4 JESD204B Frame Assembly with Decimation (Single-Band DDC): Real Output

Table 8-17 lists the available JESD204B formats and valid ranges for the ADC32RF8x with decimation (singleband DDC) when using real output format. The ranges are limited by the SerDes line rate and the maximum ADC sample frequency. The sample alignment on the different lanes is shown in Table 8-18.

DECIMATION SETTING (Complex)	NUMBER OF ACTIVE DDCS	L	м	F	s	PLL MODE	JESD MODE0	JESD MODE1	JESD MODE2	RATIO [f <sub>SerDes</sub> / f <sub>CLK</sub> (Gbps / GSPS)]	
		8	2	2	4	20x	1	0	0	2.5	
Divide-by-4 (Divide-by-2 real)	1 per channel	4	2	4	4	40x	2	0	0	5	
(,		4	2	1	1	40x	0	0	1		
	1 per channel	8	2	2	4	20x	1	0	0	1.67	
Divide-by-6 (Divide-by-3 real)		4	2	4	4	40x	2	0	0	- 3.33	
(		4	2	1	1	40x	0	0	1		

#### Table 8-17. JESD Mode Options: Single-Band Real Output (Wide Bandwidth)

### Table 8-18. JESD Sample Lane Alignment: Single-Band Real Output (Wide Bandwidth)

OUTPUT LANE	LMFS	= 8224			LMFS = 4211		
DA0	A <sub>0</sub> [15:8]	A <sub>0</sub> [7:0]					
DA1	A <sub>1</sub> [15:8]	A <sub>1</sub> [7:0]	A <sub>0</sub> [15:8]	A <sub>0</sub> [7:0]	A <sub>1</sub> [15:8]	A <sub>1</sub> [7:0]	A <sub>0</sub> [15:8]
DA2	A <sub>2</sub> [15:8]	A <sub>2</sub> [7:0]	A <sub>2</sub> [15:8]	A <sub>2</sub> [7:0]	A <sub>3</sub> [15:8]	A <sub>3</sub> [7:0]	A <sub>0</sub> [7:0]
DA3	A <sub>3</sub> [15:8]	A <sub>3</sub> [7:0]					
DB0	B <sub>0</sub> [15:8]	B <sub>0</sub> [7:0]					
DB1	B <sub>1</sub> [15:8]	B <sub>1</sub> [7:0]	B <sub>0</sub> [15:8]	B <sub>0</sub> [7:0]	B <sub>1</sub> [15:8]	B <sub>1</sub> [7:0]	B <sub>0</sub> [15:8]
DB2	B <sub>2</sub> [15:8]	B <sub>2</sub> [7:0]	B <sub>0</sub> [15:8]	B <sub>2</sub> [7:0]	B <sub>3</sub> [15:8]	B <sub>3</sub> [7:0]	B <sub>0</sub> [7:0]
DB3	B <sub>3</sub> [15:8]	B <sub>3</sub> [7:0]					



# 8.4.2.5 JESD204B Frame Assembly with Decimation (Single-Band DDC): Real Output

Table 8-19 lists the available JESD204B formats and valid ranges for the ADC32RF8x with decimation (dualband DDC) when using a complex output format. The sample alignment on the different lanes is shown in Table 8-20.

DECIMATION SETTING (Complex)	NUMBER OF ACTIVE DDCS	L	м	F	S	PLL MODE	JESD MODE0	JESD MODE1	JESD MODE2	RATIO [f <sub>SerDes</sub> / f <sub>CLK</sub> (Gbps / GSPS)]
		4	2	1	1	20x	1	1	0	2.5
Divide-by-8	4	4	2	2	2	20x	1	0	0	2.5
(Divide-by-4 real)	1 per channel	2	2	2	1	40x	0	0	1	5
		2	2	4	2	40x	2	0	0	5
		4	2	1	1	20x	1	1	0	2.22
Divide-by-9	1 per channel	4	2	2	2	20x	1	0	0	
(Divide-by-4.5 real)	i per channer	2	2	2	1	40x	0	0	1	4.44
		2	2	4	2	40x	2	0	0	4.44
Divide-by-10 (Divide-by-5 real)		4	2	1	1	20x	1	1	0	2
	1 por channel	4	2	2	2	20x	1	0	0	2
	1 per channel	2	2	2	1	40x	0	0	1	4
		2	2	4	2	40x	2	0	0	4
	1 per channel	4	2	1	1	20x	1	1	0	1.67
Divide-by-12		4	2	2	2	20x	1	0	0	1.07
(Divide-by-6 real)		2	2	2	1	40x	0	0	1	3.33
		2	2	4	2	40x	2	0	0	
		4	2	1	1	20x	1	1	0	1.25
Divide-by-16	1 por channel	4	2	2	2	20x	1	0	0	1.20
(Divide-by-8 real)	1 per channel	2	2	2	1	40x	0	0	1	- 2.5
		2	2	4	2	40x	2	0	0	2.5
		4	2	1	1	20x	1	1	0	1.11
Divide-by-18	1 per channel	4	2	2	2	20x	1	0	0	1.11
(Divide-by-9 real)	i per channer	2	2	2	1	40x	0	0	1	2.22
		2	2	4	2	40x	2	0	0	2.22
		4	2	1	1	20x	1	1	0	1
Divide-by-20	1 per channel	4	2	2	2	20x	1	0	0	
(Divide-by-10 real)	i per channel	2	2	2	1	40x	0	0	1	2
		2	2	4	2	40x	2	0	0	2
Divide-by-24	1 per channel	2	2	2	1	40x	0	0	1	1.67
(Divide-by-12 real)	i per channel	2	2	4	2	40x	2	0	0	
Divide-by-32	1 per channel	2	2	2	1	40x	0	0	1	- 1.25
(Divide-by-16 real)	i per channel	2	2	4	2	40x	2	0	0	

# Table 8-19. JESD Mode Options: Single-Band Real Output

# Table 8-20. JESD Sample Lane Assignment: Single-Band Real Output

OUTPUT LANE	LMFS = 4211	LMFS = 4222		LMFS = 2221		LMFS = 2242				
DA0	A <sub>0</sub> [15:8]	A <sub>0</sub> [15:8]	A <sub>0</sub> [7:0]							
DA1	A <sub>0</sub> [7:0]	A <sub>1</sub> [15:8]	A <sub>1</sub> [7:0]	A <sub>0</sub> [15:8]	A <sub>0</sub> [7:0]	A <sub>0</sub> [15:8]	A <sub>0</sub> [7:0]	A <sub>1</sub> [15:8]	A <sub>1</sub> [7:0]	
DB0	B <sub>0</sub> [15:8]	B <sub>0</sub> [15:8]	B <sub>0</sub> [7:0]							
DB1	B <sub>0</sub> [7:0]	B <sub>1</sub> [15:8]	B <sub>1</sub> [7:0]	B <sub>0</sub> [15:8]	B <sub>0</sub> [7:0]	B <sub>0</sub> [15:8]	B <sub>0</sub> [7:0]	B <sub>1</sub> [15:8]	B <sub>1</sub> [7:0]	



#### 8.4.2.6 JESD204B Frame Assembly with Decimation (Dual-Band DDC): Complex Output

Table 8-21 lists the available JESD204B formats and valid ranges for the ADC32RF8x with decimation (dualband DDC) when using a complex output format. The ranges are limited by the SerDes line rate and the maximum ADC sample frequency. The sample alignment on the different lanes is shown in Table 8-22.

DECIMATION SETTING (Complex)	NUMBER OF ACTIVE DDCS	L	М	F	S	PLL MODE	JESD MODE0	JESD MODE1	JESD MODE2	RATIO [f <sub>SerDes</sub> / f <sub>CLK</sub> (Gbps / GSPS)]
Divide-by-8	2 per channel	8	8	2	1	20x	1	0	0	2.5
Divide-by-6	2 per channer	4	8	4	1	40x	2	0	0	5
Divide by 0	2 per obennel	8	8	2	1	20x	1	0	0	2.22
Divide-by-9	2 per channel	4	8	4	1	40x	2	0	0	4.44
Divide-by-10	2 per channel	8	8	2	1	20x	1	0	0	2
Divide-by-10		4	8	4	1	40x	2	0	0	4
Divide-by-12	2 per channel	8	8	2	1	20x	1	0	0	1.67
Divide-by-12		4	8	4	1	40x	2	0	0	3.33
Divide-by-16	2 per channel	8	8	2	1	20x	1	0	0	1.25
Divide-by-16		4	8	4	1	40x	2	0	0	2.5
Divide-by-18	2 per channel	8	8	2	1	20x	1	0	0	1.11
Divide-by-16		4	8	4	1	40x	2	0	0	2.22
Divido by 20	2 per obappal	8	8	2	1	20x	1	0	0	1
Divide-by-20	2 per channel	4	8	4	1	40x	2	0	0	2
Divide-by-24	2 per channel	4	8	4	1	40x	2	0	0	1.67
Divide-by-32	2 per channel	4	8	4	1	40x	2	0	0	1.25

#### Table 8-21. JESD Mode Options: Dual-Band Complex Output

#### Table 8-22. JESD Sample Lane Assignment: Dual-Band Complex Output<sup>(1)</sup>

OUTPUT LANE	LMFS	= 8821	LMFS = 4841				
DA0	A1 <sub>0</sub> [15:8]	A1 <sub>0</sub> [7:0]					
DA1	A1Q <sub>0</sub> [15:8]	A1Q <sub>0</sub> [7:0]	A1I <sub>0</sub> [15:8]	A1I <sub>0</sub> [7:0]	A1Q <sub>0</sub> [15:8]	A1Q <sub>0</sub> [7:0]	
DA2	A2I <sub>0</sub> [15:8]	A2I <sub>0</sub> [7:0]	A2I <sub>0</sub> [15:8]	A2I <sub>0</sub> [7:0]	A2Q <sub>0</sub> [15:8]	A2Q <sub>0</sub> [7:0]	
DA3	A2Q <sub>0</sub> [15:8]	A2Q <sub>0</sub> [7:0]					
DB0	B1I <sub>0</sub> [15:8]	B1I <sub>0</sub> [7:0]					
DB1	B1Q <sub>0</sub> [15:8]	B1Q <sub>0</sub> [7:0]	B1I <sub>0</sub> [15:8]	B1I <sub>0</sub> [7:0]	B1Q <sub>0</sub> [15:8]	B1Q <sub>0</sub> [7:0]	
DB2	B2I <sub>0</sub> [15:8]	B2I <sub>0</sub> [7:0]	B2I <sub>0</sub> [15:8]	B2I <sub>0</sub> [7:0]	B2Q <sub>0</sub> [15:8]	B2Q <sub>0</sub> [7:0]	
DB3	B2Q <sub>0</sub> [15:8]	B2Q <sub>0</sub> [7:0]					

(1) Blue and green shading indicates the two bands for channel A; yellow and orange shading indicates the two bands for channel B.



# 8.4.2.7 JESD204B Frame Assembly with Decimation (Dual-Band DDC): Real Output

Table 8-23 lists the available JESD204B formats and valid ranges for the ADC32RF8x with decimation (dualband DDC) when using real output format. The ranges are limited by the SerDes line rate and the maximum ADC sample frequency. The sample alignment on the different lanes is shown in Table 8-24.

DECIMATION SETTING (Complex)	NUMBER OF ACTIVE DDCS	L	м	F	S	PLL MODE	JESD MODE0	JESD MODE1	JESD MODE2	RATIO [f <sub>SerDes</sub> / f <sub>CLK</sub> (Gbps / GSPS)]
		8	4	1	1	20x	1	1	0	2.5
Divide-by-8	2 nor shannel	8	4	2	2	20x	1	0	0	2.5
(Divide-by-4 real)	2 per channel	4	4	2	1	40x	0	0	1	5
		4	4	4	2	40x	2	0	0	5
		8	4	1	1	20x	1	1	0	2.22
Divide-by-9	2 per channel	8	4	2	2	20x	1	0	0	2.22
(Divide-by-4.5 real)	2 per channer	4	4	2	1	40x	0	0	1	4.44
		4	4	4	2	40x	2	0	0	4.44
		8	4	1	1	20x	1	1	0	2
Divide-by-10	2 per channel	8	4	2	2	20x	1	0	0	2
(Divide-by-5 real)	2 per channel	4	4	2	1	40x	0	0	1	4
		4	4	4	2	40x	2	0	0	
	2 per channel	8	4	1	1	20x	1	1	0	1.67
Divide-by-12		8	4	2	2	20x	1	0	0	
(Divide-by-6 real)		4	4	2	1	40x	0	0	1	3.33
		4	4	4	2	40x	2	0	0	
	2 per channel	8	4	1	1	20x	1	1	0	2.5
Divide-by-16		8	4	2	2	20x	1	0	0	
(Divide-by-8 real)		4	4	2	1	40x	0	0	1	
		4	4	4	2	40x	2	0	0	2.0
		8	4	1	1	20x	1	1	0	1.11
Divide-by-18	2 per channel	8	4	2	2	20x	1	0	0	1.11
(Divide-by-9 real)	2 per channer	4	4	2	1	40x	0	0	1	2.22
		4	4	4	2	40x	2	0	0	2.22
		8	4	1	1	20x	1	1	0	1
Divide-by-20	2 per channel	8	4	2	2	20x	1	0	0	
(Divide-by-10 real)	2 per channel	4	4	2	1	40x	0	0	1	0
		4	4	4	2	40x	2	0	0	2
Divide-by-24	2 per channel	4	4	2	1	40x	0	0	1	1.67
(Divide-by-12 real)		4	4	4	2	40x	2	0	0	1.07
Divide-by-32	2 por channel	4	4	2	1	40x	0	0	1	1.25
(Divide-by-16 real)	2 per channel	4	4	4	2	40x	2	0	0	1.20

# Table 8-23. JESD Mode Options: Dual-Band Real Output

# Table 8-24. JESD Sample Lane Assignment: Dual-Band Complex Output

OUTPUT LANE	LMFS = 8411	LMFS	= 8422	LMFS = 4421		LMFS = 4442				
DA0	A1 <sub>0</sub> [15:8]	A1 <sub>0</sub> [15:8]	A1 <sub>0</sub> [7:0]							
DA1	A1 <sub>0</sub> [7:0]	A1 <sub>1</sub> [15:8]	A1 <sub>1</sub> [7:0]	A1 <sub>0</sub> [15:8]	A1 <sub>0</sub> [7:0]	A1 <sub>0</sub> [15:8]	A1 <sub>0</sub> [7:0]	A1 <sub>1</sub> [15:8]	A1 <sub>1</sub> [7:0]	
DA2	A2 <sub>0</sub> [15:8]	A2 <sub>0</sub> [15:8]	A2 <sub>0</sub> [7:0]	A2 <sub>0</sub> [15:8]	A2 <sub>0</sub> [7:0]	A2 <sub>0</sub> [15:8]	A2 <sub>0</sub> [7:0]	A2 <sub>1</sub> [15:8]	A2 <sub>1</sub> [7:0]	
DA3	A2 <sub>0</sub> [7:0]	A2 <sub>1</sub> [15:8]	A2 <sub>1</sub> [7:0]							
DB0	B1 <sub>0</sub> [15:8]	B1 <sub>0</sub> [15:8]	B1 <sub>0</sub> [7:0]							
DB1	B1 <sub>0</sub> [7:0]	B1 <sub>1</sub> [15:8]	B1 <sub>1</sub> [7:0]	B1 <sub>0</sub> [15:8]	B1 <sub>0</sub> [7:0]	B1 <sub>0</sub> [15:8]	B1 <sub>0</sub> [7:0]	B1 <sub>1</sub> [15:8]	B1 <sub>1</sub> [7:0]	
DB2	B2 <sub>0</sub> [15:8]	B2 <sub>0</sub> [15:8]	B2 <sub>0</sub> [7:0]	B2 <sub>0</sub> [15:8]	B2 <sub>0</sub> [7:0]	B2 <sub>0</sub> [15:8]	B2 <sub>0</sub> [7:0]	B2 <sub>1</sub> [15:8]	B2 <sub>1</sub> [7:0]	
DB3	B2 <sub>0</sub> [7:0]	B2 <sub>1</sub> [15:8]	B2 <sub>1</sub> [7:0]							



# 8.4.3 Serial Interface

The ADC has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock), and SDIN (serial interface data) pins. Serially shifting bits into the device is enabled when SEN is low. SDIN serial data are latched at every SCLK rising edge when SEN is active (low), as shown in Figure 8-56. The interface can function with SCLK frequencies from 20 MHz down to low speeds (of a few hertz) and also with a non-50% SCLK duty cycle, as shown in Table 8-25.

The SPI access uses 24 bits consisting of eight register data bits, 12 register address bits, and four special bits to distinguish between read/write, page and register, and individual channel access, as described in Table 8-26.



# Figure 8-56. SPI Timing Diagram

#### Table 8-25. SPI Timing Information

		•			
		MIN	TYP	MAX	UNIT
f <sub>SCLK</sub>	SCLK frequency (equal to 1 / t <sub>SCLK</sub> )	1		20	MHz
t <sub>SLOADS</sub>	SEN to SCLK setup time	50			ns
t <sub>SLOADH</sub>	SCLK to SEN hold time	50			ns
t <sub>DSU</sub>	SDIN setup time	10			ns
t <sub>DH</sub>	SDIN hold time	10			ns
t <sub>SDOUT</sub>	Delay between SCLK falling edge to SDOUT		10		ns



# Table 8-26. SPI Input Description

SPI BIT	DESCRIPTION	OPTIONS
R/W bit	Read/write bit	0 = SPI write 1 = SPI read back
M bit	SPI bank access	0 = Analog SPI bank (master) 1 = All digital SPI banks (main digital, interleaving, decimation filter, JESD digital, and so forth)
P bit	JESD page selection bit	0 = Page access 1 = Register access
CH bit	SPI access for a specific channel of the JESD SPI bank	0 = Channel A 1 = Channel B
ADDR[11:0]	SPI address bits	_
DATA[7:0]	SPI data bits	—

Figure 8-57 shows the SDOUT timing when data are read back from a register. Data are placed on the SDOUT bus at the SCLK falling edge so that the data can be latched at the SCLK rising edge by the external receiver.



Figure 8-57. SDOUT Timing





# 8.4.3.1 Serial Register Write: Analog Bank

The internal register of the ADC32RF8x analog bank (Figure 8-58) can be programmed by:

- 1. Driving the SEN pin low.
- Initiating a serial interface cycle selecting the page address of the register whose content must be written. To select the master page: write address 0012h with 04h. To select the ADC page: write address 0011h with FFh.
- 3. Writing the register content. When a page is selected, multiple registers located in the same page can be programmed.



Figure 8-58. SPI Write Timing Diagram for the Analog Bank

# 8.4.3.2 Serial Register Readout: Analog Bank

Contents of the registers located in the two pages of the analog bank (Figure 8-59) can be readback by:

- 1. Driving the SEN pin low.
- 2. Selecting the page address of the register whose content must be read. Master page: write address 0012h with 04h. ADC page: write address 0011h with FFh.
- 3. Setting the R/W bit to 1 and writing the address to be read back.
- 4. Reading back the register content on the SDOUT pin. When a page is selected, the contents of multiple registers located in same page can be readback.



# Figure 8-59. SPI Read Timing Diagram for the Analog Bank



### 8.4.3.3 Serial Register Write: Digital Bank

The digital bank contains seven pages (Offset Corrector Page for channel A and B; Digital Gain Page for channel A and B; Main digital Page for channel A and B; and JESD Digital Page). The timing for the individual page selection is shown in Figure 8-60. The registers located in the pages of the digital bank can be programmed by:

- 1. Driving the SEN pin low.
- 2. Setting the M bit to 1 and specifying the page with the desired register. There are seven pages in Digital Bank. These pages can be selected by appropriately programming register bits DIGITAL BANK PAGE SEL, located in addresses 002h, 003h, and 004h, using three consecutive SPI cycles. Addressing in a SPI cycle begins with 4xxx when selecting a page from digital bank because the M bit must be set to 1.
  - To select the offset corrector page channel A: write address 4004h with 61h, 4003h with 00h, and 4002h with 00h.
  - To select the offset corrector page channel B: write address 4004h with 61h, 4003h with 01h, and 4002h with 00h.
  - To select the digital gain page channel A: write address 4004h with 61h, 4003h with 00h, and 4002h with 05h.
  - To select the digital gain page channel B: write address 4004h with 61h, 4003h with 01h, and 4002h with 05h.
  - To select the main digital page channel A: write address 4004h with 68h, 4003h with 00h, and 4002h with 00h.
  - To select the main digital page channel B: write address 4004h with 68h, 4003h with 01h, and 4002h with 00h.
  - To select the JESD digital page: write address 4004h with 69h, 4003h with 00h, and 4002h with 00h.

	0 1 0 0 Register Address [11:0] Register Data [7:0]
SDIN ·	
SCLK	
SEN	
RESET .	<u>Γ_</u>

# Figure 8-60. SPI Write Timing Diagram for Digital Bank Page Selection



3. Writing into the desired register by setting both the M bit and P bit to 1. Write register content. When a page is selected, multiple writes into the same page can be done. Addressing in an SPI cycle begins with 6xxx when selecting a page from the digital bank because the M bit must be set to 1, as shown in Figure 8-61.

Note that the JESD digital page is common for both channels. The CH bit can be used to distinguish between two channels when programming registers in the JESD digital page. When CH = 0, registers are programmed for channel B; when CH = 1, registers are programmed for channel A. Thus, an SPI cycle to program registers for channel B begins with 6xxx and channel A begins with 7xxx.



Figure 8-61. SPI Write Timing Diagram for Digital Bank Register Write



# 8.4.3.4 Serial Register Readout: Digital Bank

Readback of the register in one of the digital banks (as shown in Figure 8-62) can be accomplished by:

- 1. Driving the SEN pin low.
- 2. Selecting the page in the digital page: follow step 2 in the Section 8.4.3.3 section.
- 3. Set the R/W, M, and P bits to 1, select channel A or channel B, and write the address to be read back.
  JESD digital page: use the CH bit to select channel B (CH = 0) or channel A (CH = 1).
- 4. Read back the register content on the SDOUT pin. When a page is selected, multiple read backs from the same page can be done.



Figure 8-62. SPI Read Timing Diagram for the Digital Bank

# 8.4.3.5 Serial Register Write: Decimation Filter and Power Detector Pages

The decimation filter and power detector pages are special pages that accept direct addressing. The sampling clock and SYSREF signal are required to properly configure the decimation settings. Registers located in these pages can be programmed in one SPI cycle (Figure 8-63).

- 1. Drive the SEN pin low.
- Directly write to the decimation filter or power detector pages. To program registers in these pages, set M = 1 and CH = 1. Additionally, address bit A[10] selects the decimation filter page (A[10] = 0) or the power detector pages (A[10] = 1). Address bit A[11] selects the decimation filter page (A[10] = 1).
  - detector page (A[10] = 1). Address bit A[11] selects channel A (A[11] = 0) or channel B (A[11] = 1).
  - Decimation filter page: write address 50xxh for channel A or 58xxh for channel B.
  - Power detector page: write address 54xxh for channel A or 5Cxxh for channel B.

Example: Writing address 5001h with 02h selects the decimation filter page for channel A and programs decimation factor of divide-by-8 (complex output).



Figure 8-63. SPI Write Timing Diagram for the Decimation and Power Detector Pages



# 8.5 Register Maps

The ADC32RF8x contains two main SPI banks. The analog SPI bank provides access to the ADC core and the digital SPI bank controls the digital blocks (including the serial JESD interface). Figure 8-64 and Figure 8-65 provide a conceptual view of the SPI registers inside the ADC32RF8x. The analog SPI bank contains the master and ADC pages. The digital SPI bank is divided into multiple pages (the main digital, digital gain, decimation filter, JESD digital, and power detector pages).



- A. In general, SPI writes are completed in two steps. The first step is to access the necessary page. The second step is to program the desired register in that page. When a page is accessed, the registers in that page can be programmed multiple times.
- B. Registers in the decimation filter page and the power detector page can be directly programmed in one SPI cycle.
- C. The CH bit is a *don't care* bit and is recommended to be kept at 0.

# Figure 8-64. SPI Registers, Two-Step Addressing





SCLK

SEN



Registers in the decimation filter page and the power detector page can be directly programmed in one SPI cycle. Α.

To program registers in the decimation filter page, set M = 1, CH = 1, A[10] = 0, and A[11] = 0 or 1 for channel A or B. Addressing begins at 50xx for channel A and 58xx for channel B. Β.

C. To program registers in power detector page, set M = 1, CH = 1, A[10] = 1, and A[11] = 0 or 1 for channel A or B. Addressing begins at 54xx for channel A and 5Cxx for channel B.

# Figure 8-65. SPI Registers: Direct Addressing


Table 8-27 lists the register map for the ADC32RF8x.

REGISTER				REGIST	ER DATA				
ADDRESS A[11:0] (Hex)	7 6 5		5	4	3	2	1	0	
GENERAL REGIST	ERS						I.		
000	RESET	0	0	0	0	0	0	RESET	
002				DIGITAL BANK	PAGE SEL[7:0]				
003				DIGITAL BANK	PAGE SEL[15:8]				
004				DIGITAL BANK	PAGE SEL[23:16]				
010	0	0	0	0	0	0	0	3 or 4 WIRE	
011				ADC PA	GE SEL				
012	0	0	0	0	0	MASTER PAGE SEL	0	0	
MASTER PAGE (M	= 0)								
020	0	0	0	PDN SYSREF	0	0	PDN CHB	GLOBAL PDN	
032	0	0	INCR CM IMPEDANCE	0	0	0	0	0	
039	0	ALWAYS WRITE 1	0	ALWAYS WRITE 1	0	0	PDN CHB EN	SYNC TERM DIS	
03C	0	SYSREF DEL EN	0	0	0	0 SYSREF DEL		DEL[4:3]	
03D	0	0	0	0	0		JESD OUTPUT SWIN	WING	
05A		SYSREF DEL[2:0]		0	0	0	0	0	
057	0	0	0	SEL SYSREF REG	ASSERT SYSREF REG	0	0	0	
058	0	0	SYNCB POL	0	0	0	0	0	
ADC PAGE (FFh, M	Λ = 0)								
03F	0	0	0	0	0	SLOW SP EN1	0	0	
042	0	0	0	SLOW SP EN2	0	0	1	1	
Offset Corr Page C	hannel A (610000h, I	M = 1)							
68	FREEZE OFFSET CORR	ALWAYS WRITE 1	0	0	0	DIS OFFSET CORR	ALWAYS WRITE 1	0	
Offset Corr Page C	 Channel B (610100h, I	M = 1)		1	1		1		
68	FREEZE OFFSET CORR	ALWAYS WRITE 1	0	0	0	DIS OFFSET CORR	ALWAYS WRITE 1	0	
Digital Gain Page	Channel A (610005, N	1 = 1)			1		1		
0A6	0	0	0	0		DIGIT	AL GAIN		

#### ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021



REGISTER				. Register Map (o REGISTE	,			
ADDRESS								
A[11:0] (Hex)	7	6	5	4	3	2	1	0
Digital Gain Page (	Channel B (610105, N	l = 1)						
0A6	0	0	0	0		DIGITA	AL GAIN	
Main Digital Page	Channel A (680000h,	M = 1)						
000	0	0	0	0	0	0	0	DIG CORE RESET GBL
0A2	0	0	0	0	NQ ZONE EN		NYQUIST ZONE	1
Main Digital Page	Channel B (680001h,	M = 1)	L			1		
000	0	0	0	0	0	0	0	0
0A2	0	0	0	0	NQ ZONE EN		NYQUIST ZONE	
JESD DIGITAL PAG	GE (690000h, M = 1)	l						
001	CTRL K	0	0	TESTMODE EN	0	LANE ALIGN	FRAME ALIGN	TX LINK DIS
002	SYNC REG	SYNC REG EN	0	0	12BIT	MODE	JESD	MODE0
003	LI	LINK LAYER TESTMODE		LINK LAY RPAT	LMFC MASK RESET	JESD MODE1	JESD MODE2	RAMP 12BIT
004	0	0	0	0	0	0	REL II	A SEQ
006	SCRAMBLE EN	0	0	0	0	0	0	0
007	0	0	0		FRAM	IES PER MULTIFRAI	ME (K)	
016	0		40X MODE		0	0	0	0
017	0	0	0	0	LANE0 POL	LANE1 POL	LANE2 POL	LANE3 POL
032		1	SEL EMF	P LANE 0			0	0
033			SEL EMF	P LANE 1			0	0
034			SEL EMF	P LANE 2			0	0
035			SEL EMF	P LANE 3			0	0
036	0	CMOS SYNCB	0	0	0	0	0	0
037	0	0	0	0	0	0	PLL	MODE
03C	0	0	0	0	0	0	0	EN CMOS SYNCE
03E	0	MASK CLKDIV SYSREF	MASK NCO SYSREF	0	0	0	0	0



			Table 8-27	. Register Map (	continued)			
REGISTER				REGIST	ER DATA			
ADDRESS A[11:0] (Hex)	7	6	5	4	3	2	1	0
DECIMATION FILTE	R PAGE (Direct Ad	dressing, 16-Bit Add	ress, 5000h for Char	nel A and 5800h for	Channel B)			
000	0	0	0	0	0	0	0	DDC EN
001	0	0	0	0		DECIM	FACTOR	1
002	0	0	0	0	0	0	0	DUAL BAND EN
005	0	0	0	0	0	0	0	REAL OUT EN
006	0	0	0	0	0	0	0	DDC MUX
007				DDC0 N	CO1 LSB			
008				DDC0 NO	CO1 MSB			
009				DDC0 N	CO2 LSB			
A00				DDC0 NO	CO2 MSB			
00B		DDC0 NCO3 LSB						
00C		DDC0 NCO3 MSB						
00D				DDC1 N	CO4 LSB			
00E				DDC1 N	CO4 MSB			
00F	0	0	0	0	0	0	0	NCO SEL PIN
010	0	0	0	0	0	0	NCC	) SEL
011	0	0	0	0	0	0	LMFC RE	SET MODE
014	0	0	0	0	0	0	0	DDC0 6DB GAIN
016	0	0	0	0	0	0	0	DDC1 6DB GAIN
01E	0		DDC DET LAT		0	0	0	0
01F	0	0	0	0	0	0	0	WBF 6DB GAIN
033		ŀ	·	CUSTOM PA	TTERN1[7:0]			
034				CUSTOM PA	FTERN1[15:8]			
035				CUSTOM PA	TTERN2[7:0]			
036				CUSTOM PA	FTERN2[15:8]			
037		TEST PATTERN	N DDC1 Q-DATA			TEST PATTER	N DDC1 I-DATA	
038		TEST PATTERN	N DDC2 Q-DATA			TEST PATTER	N DDC2 I -DATA	
039	0	0	0	0	0	0	0	USE COMMON TEST PATTERN
03A	0	0	0	0	0	0	TEST PAT RES	TP RES EN

#### ADC32RF80, ADC32RF83 SBAS774B – MAY 2016 – REVISED DECEMBER 2021



	1		Table 8-27	. Register Map				
REGISTER ADDRESS		_	1	REGIS	TER DATA	_	1	
ADDRESS A[11:0] (Hex)	7	6	5	4	3	2	1	0
POWER DETECTO	R PAGE (Direct Add	lressing, 16-Bit Addr	ess, 5400h for Chan	nel A and 5C00h fo	or Channel B)			
000	0	0	0	0	0	0	0	PKDET EN
001		1	1	BLKPI	KDET [7:0]		1	
002				BLKPK	(DET [15:8]			
003	0	0	0	0	0	0	0	BLKPKDET [16]
007				BL	КТННН			
008				BL	KTHHL			
009				BL	KTHLH			
00A				BL	KTHLL			
00B				DW	ELL[7:0]			
00C				DWE	ELL[15:8]			
00D	0	0	0	0	0	0	0	FILTOLPSEL
00E	0	0 0 0 0 TIMECONST						
00F		FILOTHH[7:0]						
010		FILOTHH[15:8]						
011				FILO	THL[7:0]			
012				FIL0 <sup>-</sup>	THL[15:8]			
013	0	0	0	0	0	0	0	IIR0 2BIT EN
016		1		FIL1	THH[7:0]			L
017				FIL17	THH[15:8]			
018				FIL1	THL[7:0]			
019				FIL1	THL[15:8]			
01A	0	0	0	0	0	0	0	IIR1 2BIT EN
01D				DWE	LLIIR[7:0]			
01E				DWEL	_LIIR[15:8]			
020	0	0	0	0	0	0	0	IIR0 2BIT EN
021	0	0	0			PWRDETACCU		
022				PWRI	DETH[7:0]			
023				PWRD	DETH[15:8]			
024				PWR	DETL[7:0]			
025				PWR	DETL[15:8]			



			Table 8-27	. Register Map (	continued)					
REGISTER	REGISTER DATA									
ADDRESS A[11:0] (Hex)	7	6	5	4	3	2	1	0		
POWER DETECTO	R PAGE (continued)							·		
027	0	0	0	0	0	0	0	RMS 2BIT EN		
02B	0	0	0	RESET AGC	0	0	0	0		
032		OUTSEL GPIO4								
033				OUTSE	L GPIO1					
034				OUTSE	L GPIO3					
035				OUTSE	L GPIO2					
037	0	0	0	0	IODIR GPIO2	IODIR GPIO3	IODIR GPIO1	IODIR GPIO4		
038	0	0	INS	EL1	0	0	INS	EL0		



#### 8.5.1 Example Register Writes

This section provides three different example register writes. Table 8-28 describes a global power-down register write, Table 8-29 describes the register writes when the scrambler is enabled, and Table 8-30 describes the register writes for 8x decimation for channels A and B (complex output, 1 DDC mode) with the NCO set to 1.8 GHz ( $f_S$  = 3 GSPS) and the JESD format configured to LMFS = 4421.

	Table 8-28. Global Power-Down					
ADDRESS	ADDRESS DATA COMMENT					
12h	12h 04h Set the master page					
20h 01h Set the global power-down						

#### Table 8-29. Scrambler Enable

ADDRESS	DATA	COMMENT			
4004h	69h	Select the digital JESD page			
4003h	00h	Select the digital JESD page			
6006h	80h	Scrambler enable, channel A			
7006h	80h	Scrambler enable, channel B			

#### Table 8-30. 8x Decimation for Channel A and B

ADDRESS	DATA	COMMENT
4004h	68h	Colort the main divital name for abannel A
4003h	00h	Select the main digital page for channel A
6000h	01h	Issue a digital reset for channel A
6000h	00h	Clear the digital for reset channel A
4003h	01h	Select the main digital page for channel B
6000h	01h	Issue a digital reset for channel B
6000h	00h	Clear the digital reset for channel B
4004h	69h	Calent the digital IECD page
4003h	00h	Select the digital JESD page
6002h	01h	Set JESD MODE0 = 1, channel A
7002h	01h	Set JESD MODE0 = 1, channel B
5000h	01h	Enable the DDC, channel A
5001h	02h	Set decimation to 8x complex
5007h	9Ah	Set the LSB of DDC0, NCO1 to 9Ah (f <sub>NCO</sub> = 1.8 GHz, f <sub>S</sub> = 3 GSPS)
5008h	99h	Set the MSB of DDC0, NCO1 to 99h (f <sub>NCO</sub> = 1.8 GHz, f <sub>S</sub> = 3 GSPS)
5014h	01h	Enable the 6-dB digital gain of DDC0
5801h	02h	Set decimation to 8x complex
5807h	9Ah	Set the LSB of DDC0, NCO1 to 9Ah (f <sub>NCO</sub> = 1.8 GHz, f <sub>S</sub> = 3 GSPS)
5808h	99h	Set the MSB of DDC0, NCO1 to 99h (f <sub>NCO</sub> = 1.8 GHz, f <sub>S</sub> = 3 GSPS)
5814h	01h	Enable the 6-dB digital gain of DDC0

#### 8.5.2 Register Descriptions

#### 8.5.2.1 General Registers

#### 8.5.2.1.1 Register 000h (address = 000h), General Registers

#### Figure 8-36, Register 000h

			<u></u>				
7	6	5	4	3	2	1	0
RESET	0	0	0	0	0	0	RESET
R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h



#### Table 8-31. Register 000h Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESET	R/W	0h	0 = Normal operation 1 = Internal software reset, clears back to 0
6-1	0	W	0h	Must write 0
0	RESET	R/W	0h	0 = Normal operation <sup>(1)</sup> 1 = Internal software reset, clears back to 0

(1) Both bits (7, 0) must be set simultaneously to perform a reset.

#### 8.5.2.1.2 Register 002h (address = 002h), General Registers

#### Figure 8-37. Register 002h

7	6	5	4	3	2	1	0	
	DIGITAL BANK PAGE SEL[7:0]							
	R/W-0h							

#### Table 8-32. Register 002h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DIGITAL BANK PAGE SEL[7:0]	R/W		Program the JESD BANK PAGE SEL[23:0] bits to access the desired page in the JESD bank. 680000h = Main digital page CHA selected 680100h = Main digital page CHB selected 610000h = Digital function page CHA selected 610100h = Digital function page CHB selected 690000h = JESD digital page selected



#### 8.5.2.1.3 Register 003h (address = 003h), General Registers

#### Figure 8-38. Register 003h

7	6	5	5 4		2	1	0
	DIGITAL BANK PAGE SEL[15:8]						
	R/W-0h						

#### Table 8-33. Register 003h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DIGITAL BANK PAGE SEL[15:8]	R/W		Program the JESD BANK PAGE SEL[23:0] bits to access the desired page in the JESD bank. 680000h = Main digital page CHA selected 680100h = Main digital page CHB selected 610000h = Digital function page CHA selected 610100h = Digital function page CHB selected 690000h = JESD digital page selected

#### 8.5.2.1.4 Register 004h (address = 004h), General Registers

Figure 8-39. Register 004h								
7	7 6 5 4 3 2 1 0							
			DIGITAL BANK F	PAGE SEL[23:16]				
			R/W	V-0h				

#### Table 8-34. Register 004h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DIGITAL BANK PAGE SEL[23:16]	R/W		Program the JESD BANK PAGE SEL[23:0] bits to access the desired page in the JESD bank. 680000h = Main digital page CHA selected 680100h = Main digital page CHB selected 610000h = Digital function page CHA selected 610100h = Digital function page CHB selected 690000h = JESD digital page selected

#### 8.5.2.1.5 Register 010h (address = 010h), General Registers

#### Figure 8-40. Register 010h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	3 or 4 WIRE
W-0h	R/W-0h						

#### Table 8-35. Register 010h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	3 or 4 WIRE	R/W	0h	0 = 4-wire SPI (default) 1 = 3-wire SPI where SDIN become input or output



#### 8.5.2.1.6 Register 011h (address = 011h), General Registers

Figure 8-41. Register 011h								
7	6 5 4 3 2 1 0							
	ADC PAGE SEL							
	R/W-0h							

#### Table 8-36. Register 011h Field Descriptions

Bit	Field	Туре	Reset	Description			
7-0	ADC PAGE SEL	R/W		00000000 = Normal operation, ADC page is not selected 11111111 = ADC page is selected; MASTER PAGE SEL must be			
				set to 0			

#### 8.5.2.1.7 Register 012h (address = 012h), General Registers

	Figure 8-42. Register 012h							
7	6	5	4	3	2	1	0	
0	0	0	0	0	MASTER PAGE SEL	0	0	
W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	

	Table 8-37. Register 012h Field Descriptions							
Bit	Field	Туре	Reset	Description				
7-3	0	W	0h	Must write 0				
2	MASTER PAGE SEL	R/W	0h	0 = Normal operation 1 = Selects the master page address; ADC PAGE must be set to 0				
1-0	0	W	0h	Must write 0				

#### Copyright © 2021 Texas Instruments Incorporated



#### 8.5.3 Master Page (M = 0)

#### 8.5.3.1 Register 020h (address = 020h), Master Page

#### Figure 8-43. Register 020h

7	6	5	4	3	2	1	0
0	0	0	PDN SYSREF	0	0	PDN CHB	GLOBAL PDN
W-0h	W-0h	W-0h	R/W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h

#### Table 8-38. Register 020h Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	W	0h	Must write 0
4	PDN SYSREF	R/W	0h	This bit powers down the SYSREF input buffer. 0 = Normal operation 1 = SYSREF input capture buffer is powered down and further SYSREF input pulses are ignored
3-2	0	W	0h	Must write 0
1	PDN CHB	R/W	0h	This bit powers down channel B. 0 = Normal operation 1 = Channel B is powered down
0	GLOBAL PDN	R/W	0h	This bit enables the global power-down. 0 = Normal operation 1 = Global power-down enabled

#### 8.5.3.2 Register 032h (address = 032h), Master Page

#### Figure 8-44. Register 032h

7	6 5		4	3	2	1	0
0	0	INCR CM IMPEDANCE	0	0	0	0	0
W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h

#### Table 8-39. Register 032h Field Descriptions

Bit	Bit Field		Field Type Reset Description		Description		
7-6	6 0		0h	Must write 0			
5	INCR CM IMPEDANCE	R/W	0h	Only use this bit when analog inputs are dc-coupled to the driver. 0 = VCM buffer directly drives the common point of biasing resistors. 1 = VCM buffer drives the common point of biasing resistors with $> 5 \text{ k}\Omega$			
4-0	0	W	0h	Must write 0			



#### 8.5.3.3 Register 039h (address = 039h), Master Page

	Figure 8-45. Register 039h										
7	6	5	4	3	2	1	0				
0	ALWAYS WRITE 1	0	ALWAYS WRITE 1	0	0	PDN CHB EN	SYNC TERM DIS				
W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h				

#### Table 8-40. Register 039h Field Descriptions

Bit	Field	Туре	Reset	Description
7	0	W	0h	Must write 0
6	ALWAYS WRITE 1	W	0h	Always set this bit to 1
5	0	W	0h	Must write 0
4	ALWAYS WRITE 1	W	0h	Always set this bit to 1
3-2	0	W	0h	Must write 0
1	PDN CHB EN	R/W	Oh	This bit enables the power-down control of channel B through the SPI in register 20h. 0 = PDN control disabled 1 = PDN control enabled
0	SYNC TERM DIS	R/W	Oh	This bit disables the on-chip, $100-\Omega$ termination resistors on the SYNCB input. 0 = On-chip, $100-\Omega$ termination enabled 1 = On-chip, $100-\Omega$ termination disabled

#### 8.5.3.4 Register 03Ch (address = 03Ch), Master Page

#### Figure 8-46. Register 03Ch

	7 6		5	4	3	2	1 0	
	0	SYSREF DEL EN	0	0	0	0	SYSREF DEL[4:3]	
W-0h R/W-0h		R/W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	

#### Table 8-41. Register 03Ch Field Descriptions

Bit	Field	Туре	Reset	Description
7	0	W	0h	Must write 0
6	SYSREF DEL EN	input. 0 = SYSREF delay disabled		0 = SYSREF delay disabled 1 = SYSREF delay enabled through register settings [3Ch (bits
5-2	0	W	0h	Must write 0
1-0	SYSREF DEL[4:3]	R/W	0h	When the SYSREF delay feature is enabled (3Ch, bit 6) the delay can be adjusted in 25-ps steps; the first step is 175 ps. The PVT variation of each 25-ps step is $\pm 10$ ps. The 175-ps step is $\pm 50$ ps; see Table 8-43.



#### 8.5.3.5 Register 05Ah (address = 05Ah), Master Page

	Figure 8-47. Register 05Ah									
7 6 5 4 3 2 1 0										
	SYSREF DEL[2:0]		0	0	0	0	0			
W-0h R/W-0h W-0h W-0h W-0h W-0h W-0h W-0h										

#### Table 8-42. Register 05Ah Field Descriptions

Bit	Field	Type Reset Description		Description
7	SYSREF DEL2	W		When the SYSREF delay feature is enabled (3Ch, bit 6) the
6	SYSREF DEL1	R/W		delay can be adjusted in 25-ps steps; the first step is 175 ps. The PVT variation of each 25-ps step is ±10 ps. The 175-ps step
5	SYSREF DEL0	W		is $\pm 50$ ps; see Table 8-43.
4-0	0	W	0h	Must write 0

#### Table 8-43. SYSREF DEL[2:0] Bit Settings

SETTING	STEP (NOM)	TOTAL DELAY (NOM)				
01000	175 ps	175 ps				
00111	25 ps	200 ps				
00110	25 ps	225 ps				
00101	25 ps	250 ps				
00100	25 ps	275 ps				
00011	25 ps	300 ps				
	01000 00111 00110 00101 00100	01000         175 ps           00111         25 ps           00110         25 ps           00101         25 ps           00100         25 ps				

#### 8.5.3.6 Register 03Dh (address = 3Dh), Master Page

#### Figure 8-48. Register 03Dh

			U						
7	6	5	4	3	2 1 0				
0	0	0	0	0	JESD OUTPUT SWING				
W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h				

#### Table 8-44. Register 03Dh Field Descriptions

Bit	Field	Туре	Reset	Description
7-3	0	W	0h	Must write 0
2-0	JESD OUTPUT SWING	R/W	Oh	These bits select the output amplitude, $V_{OD}$ (mV <sub>PP</sub> ), of the JESD transmitter for all lanes. 0 = 860 mV <sub>PP</sub> 1 = 810 mV <sub>PP</sub> 2 = 770 mV <sub>PP</sub> 3 = 745 mV <sub>PP</sub> 4 = 960 mV <sub>PP</sub> 5 = 930 mV <sub>PP</sub> 6 = 905 mV <sub>PP</sub> 7 = 880 mV <sub>PP</sub>



#### 8.5.3.7 Register 057h (address = 057h), Master Page

Figure 8-49. Register 057h										
7	6	5	4	3	2	1	0			
0	0	0	SEL SYSREF REG	ASSERT SYSREF REG	0	0	0			
W-0h	W-0h	W-0h	R/W-0h	R/W-0h	W-0h	W-0h	W-0h			

#### Table 8-45. Register 057h Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	W	0h	Must write 0
4	SEL SYSREF REG	R/W	0h	SYSREF can be asserted using this bit. Ensure that the SEL SYSREF REG register bit is set high before using this bit; see the <i>Section 8.3.3.1</i> section. 0 = SYSREF is logic low 1 = SYSREF is logic high
3	ASSERT SYSREF REG	R/W	0h	Set this bit to use the SPI register to assert SYSREF. 0 = SYSREF is asserted by device pins 1 = SYSREF can be asserted by the ASSERT SYSREF REG register bit Other bits = 0
2-0	0	W	0h	Must write 0

#### 8.5.3.8 Register 058h (address = 058h), Master Page

#### Figure 8-50. Register 058h

7	6	5	4	3	2	1	0
0	0	SYNCB POL	0	0	0	0	0
W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h

#### Table 8-46. Register 058h Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	W	0h	Must write 0
5	SYNCB POL	R/W		This bit inverts the SYNCB polarity. 0 = Polarity is not inverted; this setting matches the timing diagrams in this document and is the proper setting to use 1 = Polarity is inverted
4-0	0	W	0h	Must write 0



#### 8.5.4 ADC Page (FFh, M = 0)

#### 8.5.4.1 Register 03Fh (address = 03Fh), ADC Page

#### Figure 8-51. Register 03Fh

			•	•			
7	6	5	4	3	2	1	0
0	0	0	0	0	SLOW SP EN1	0	0
W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h

#### Table 8-47. Register 03Fh Field Descriptions

Bit	Field	Туре	Reset	Description
7-3	0	W	0h	Must write 0
2	SLOW SP EN1	R/W	0h	This bit must be enabled for clock rates below 2.5 GSPS. 0 = ADC sampling rates are faster than 2.5 GSPS 1 = ADC sampling rates are slower than 2.5 GSPS
1-0	0	W	0h	Must write 0

#### 8.5.4.2 Register 042h (address = 042h), ADC Page

#### Figure 8-52. Register 042h

7	6	5	4	3	2	1	0
0	0	0	SLOW SP EN2	0	0	0	0
W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h

#### Table 8-48. Register 042h Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	W	0h	Must write 0
4	SLOW SP EN2	R/W		This bit must be enabled for clock rates below 2.5 GSPS. 0 = ADC sampling rates are faster than 2.5 GSPS 1 = ADC sampling rates are slower than 2.5 GSPS
3-0	0	W	0h	Must write 0



#### 8.5.5 Digital Function Page (610000h, M = 1 for Channel A and 610100h, M = 1 for Channel B)

#### Figure 8-53. Register 0A6h 5 2 7 6 0 4 3 1 0 0 0 0 **DIG GAIN** W-0h W-0h W-0h W-0h R/W-0h

#### Table 8-49. Register 0A6h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	W	0h	Must write 0
3-0	DIG GAIN	R/W	0h	These bits set the digital gain of the ADC output data prior to decimation up to 11 dB; see Table 8-50.

#### Table 8-50. DIG GAIN Bit Settings

SETTING	DIGITAL GAIN
0000	0 dB
0001	1 dB
0010	2 dB
1010	10 dB
1011	11 dB



#### 8.5.6 Offset Corr Page Channel A (610000h, M = 1)

### 8.5.6.1 Register 034h (address = 034h), Offset Corr Page Channel A

#### Figure 8-54. Register 034h

				0			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	SEL EXT EST
W-0h	R/W-0h						

#### Table 8-51. Register 034h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	SEL EXT EST	R/W	0h	This bit selects the external estimate for the offset correction block; see the Section 9.1.5 section.

#### 8.5.6.2 Register 068h (address = 068h), Offset Corr Page Channel A

Figure 8-55. Register 068h								
7	6	5	4	3	2	1	0	
FREEZE OFFSET CORR	ALWAYS WRITE 1	0	0	0	DIS OFFSET CORR	ALWAYS WRITE 1	0	
R/W-0h	R/W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h	

Bit	Field		Reset	Description
DIL		Туре		Description
7	FREEZE OFFSET CORR	OFFSET CORR R/W 0h		Use this bit and bits 5 and 1 to freeze the offset estimation process of the offset corrector; see the <i>Section 9.1.5</i> section. 011 = Apply this setting after powering up the device 111 = Offset corrector is frozen, does not estimate offset anymore, and applies the last computed value. Others = Do not use
6	ALWAYS WRITE 1	R/W	0h	Always write this bit as 1 for the offset correction block to work properly.
5	0	W	0h	Must write 0
4-3	0	W	0h	Must write 0
2	DIS OFFSET CORR	R/W	0h	0 = Offset correction block works and removes $f_S / 8$ , $f_S / 4$ , $3f_S / 8$ , and $f_S / 2$ spurs 1 = Offset correction block is disabled
1	ALWAYS WRITE 1	R/W	0h	Always write this bit as 1 for the offset correction block to work properly.
0	0	W	0h	Must write 0

#### Table 8-52. Register 068h Field Descriptions



#### 8.5.7 Offset Corr Page Channel B (610000h, M = 1)

#### 8.5.7.1 Register 068h (address = 068h), Offset Corr Page Channel B

7	6	5	4	3	2	1	0		
FREEZE OFFSET CORR	ALWAYS WRITE 1	0	0	0	DIS OFFSET CORR	ALWAYS WRITE 1	0		
R/W-0h	R/W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h		

#### Figure 8-56. Register 068h

#### Table 8-53. Register 068h Field Descriptions

Bit	Field	Туре	Reset	Description		
7	FREEZE OFFSET CORR	SET CORR R/W 0h		Use this bit and bits 5 and 1 to freeze the offset estimation process of the offset corrector; see the <i>Section 9.1.5</i> section. 011 = Apply this setting after powering up the device 111 = Offset corrector is frozen, does not estimate offset anymore, and applies the last computed value. Others = Do not use		
6	ALWAYS WRITE 1	R/W 0h Always write this bit as 1 properly.		Always write this bit as 1 for the offset correction block to work properly.		
5	0	W	0h	Must write 0		
4-3	0	W	0h	Must write 0		
2	DIS OFFSET CORR	R/W	0h	0 = Offset correction block works and removes $f_S / 8$ , $f_S / 4$ , $3f_S / 8$ , and $f_S / 2$ spurs 1 = Offset correction block is disabled		
1	ALWAYS WRITE 1			Always write this bit as 1 for the offset correction block to work properly.		
0	0	W	0h	Must write 0		

#### 8.5.8 Digital Gain Page (610005h, M = 1 for Channel A and 610105h, M = 1 for Channel B)

#### 8.5.8.1 Register 0A6h (address = 0A6h), Digital Gain Page

#### Figure 8-57. Register 0A6h

7	6	5	4	3	2	1	0	
0	0	0	0	DIGITAL GAIN				
W-0h	W-0h	W-0h	W-0h	R/W-0h				

#### Table 8-54. Register 0A6h Field Descriptions

Bit	Field	Туре	Reset	Description	
7-4	0	W	0h	Must write 0	
3-0	DIGITAL GAIN	R/W	0h	These bits apply a digital gain to the ADC data (before the DDC) up to 11 dB. 0000 = Default 0001 = 1 dB 1011 = 11 dB Others = Do not use	



#### 8.5.9 Main Digital Page Channel A (680000h, M = 1)

#### 8.5.9.1 Register 000h (address = 000h), Main Digital Page Channel A

	Figure 8-58. Register 000h										
7 6 5 4 3 2 1 0											
0	0 0 0		0	0	0	0 DIG CORE RESET GE					
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h				

#### Table 8-55. Register 000h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W 0h Must write 0		Must write 0
0	DIG CORE RESET GBL	R/W		Pulse this bit $(0 \rightarrow 1 \rightarrow 0)$ to reset the digital core (applies to both channel A and B). All Nyquist zone settings take effect when this bit is pulsed.

#### 8.5.9.2 Register 0A2h (address = 0A2h), Main Digital Page Channel A

#### Figure 8-59. Register 0A2h 7 6 5 4 3 2 1 0 0 0 0 0 NQ ZONE EN NYQUIST ZONE W-0h W-0h W-0h W-0h R/W-0h R/W-0h

#### Table 8-56. Register 0A2h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	W	0h	Must write 0
3	NQ ZONE EN	R/W	W     0h     Must write 0	
2-0	NYQUIST ZONE	R/W		



#### 8.5.10 Main Digital Page Channel B (680001h, M = 1)

#### 8.5.10.1 Register 000h (address = 000h), Main Digital Page Channel B

	Figure 8-60. Register 000h										
7 6 5 4 3 2 1								0			
	0	0 0 0		0	0	0	0	DIG CORE RESET GBL			
	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h			

#### Table 8-57. Register 000h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h Must write 0	
0	DIG CORE RESET GBL	R/W		Pulse this bit $(0 \rightarrow 1 \rightarrow 0)$ to reset the digital core (applies to both channel A and B). All Nyquist zone settings take effect when this bit is pulsed.

#### 8.5.10.2 Register 0A2h (address = 0A2h), Main Digital Page Channel B

## Figure 8-61. Register 0A2h 6 5 4 3 2 1

1	6	5	4	3	2	1	0
0	0	0	0	NQ ZONE EN		NYQUIST ZONE	
W-0h	W-0h	W-0h	W-0h	R/W-0h		R/W-0h	

#### Table 8-58. Register 0A2h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	W	0h	Must write 0
3	NQ ZONE EN	R/W	Oh	This bit allows for specification of the operating Nyquist zone. 0 = Nyquist zone specification disabled 1 = Nyquist zone specification enabled
2-0	NYQUIST ZONE	R/W	Oh	These bits specify the Nyquist band for the portion of aliased spectrum that is not spanned by the frequencies specified in the Band-Freq. registers (register addresses B0-BB). If the Band-Freq registers are not enabled, this setting specifies the common Nyquist band information for the entire aliased spectrum. Set the NQ ZONE EN bit before programming these bits. For example, at a 3-GSPS chip clock, first Nyquist zone is from dc to 1.5 GHz, the second Nyquist zone is from 1.5 GHz to 3 GHz, and so on. 000 = First Nyquist zone (dc - f <sub>S</sub> / 2) 001 = Second Nyquist zone (f <sub>S</sub> / 2 - f <sub>S</sub> ) 010 = Third Nyquist zone



#### 8.5.11 JESD Digital Page (6900h, M = 1)

#### 8.5.11.1 Register 001h (address = 001h), JESD Digital Page

#### Figure 8-62. Register 001h

7	6	5	4	3	2	1	0
CTRL K	0	0	TESTMODE EN	0	LANE ALIGN	FRAME ALIGN	TX LINK DIS
R/W-0h	W-0h	W-0h	R/W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h

#### Table 8-59. Register 001h Field Descriptions

Bit	Field	Туре	Reset	Description
7	CTRL K	R/W	0h	This bit is the enable bit for the number of frames per multiframe. 0= Default is five frames per multiframe 1= Frames per multiframe can be set in register 06h
6-5	0	R/W	0h	Must write 0
4	TESTMODE EN		0	This bit generates a long transport layer test pattern mode according to section 5.1.6.3 of the JESD204B specification. 0 = Test mode disabled 1 = Test mode enabled
3	0	W	0h	Must write 0
2	LANE ALIGN	R/W	0h	This bit inserts a lane alignment character (K28.3) for the receiver to align to the lane boundary per section 5.3.3.5 of the JESD204B specification. 0 = Normal operation 1 = Inserts lane alignment characters
1	FRAME ALIGN	R/W	0h	This bit inserts a frame alignment character (K28.7) for the receiver to align to the frame boundary per section 5.3.35 of the JESD204B specification. 0 = Normal operation 1 = Inserts frame alignment characters
0	TX LINK DIS	R/W	0h	This bit disables sending the initial link alignment (ILA) sequence when SYNC is deasserted. 0 = Normal operation 1 = ILA disabled



#### 8.5.11.2 Register 002h (address = 002h ), JESD Digital Page

Figure 8-63. Register 002h										
7 6 5 4 3 2 1 0										
SYNC REG	SYNC REG EN	0	0	12BIT	MODE	JESD I	MODE0			
R/W-0h	R/W-0h	W-0h	W-0h	R/W	/-0h	R/V	V-0h			

#### Table 8-60. Register 002h Field Descriptions

Bit	Field	Туре	Reset	Description
7	SYNC REG	R/W	Oh	This bit provides SYNC control through the SPI. 0 = Normal operation 1 = ADC output data are replaced with K28.5 characters
6	SYNC REG EN	R/W	Oh	This bit is the enable bit for SYNC control through the SPI. 0 = Normal operation 1 = SYNC control through the SPI is enabled (ignores the SYNCB input pins)
5-4	0	W	0h	Must write 0
3-2	12BIT MODE	R/W	Oh	This bit enables the 12-bit output mode for more efficient data packing. 00 = Normal operation, 14-bit output 01, 10 = Unused 11 = High-efficient data packing enabled
1-0	JESD MODE0	R/W	Oh	These bits select the configuration register to configure the correct LMFS frame assemblies for different decimation settings; see the JESD frame assembly tables in the <i>Section 8.4.2.2</i> section. 00 = 0 01 = 1 10 = 2 11 = 3



#### 8.5.11.3 Register 003h (address = 003h), JESD Digital Page

#### Figure 8-64. Register 003h

7	6	5	4	3	2	1	0
LINK LAYER TES	STMODE		LINKLAY RPAT	LMFC MASKRESET	JESDMODE1	JESDMODE2	RAMP12BIT
R/W-0h			R/W-0h	R/W-0h	R/W-1h	R/W-0h	R/W-0h

#### Table 8-61. Register 003h Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	LINK LAYER TESTMODE	R/W	Oh	These bits generate a pattern according to section 5.3.3.8.2 of the JESD204B document.000= Normal ADC data001= D21.5 (high-frequency jitter pattern) 010 = K28.5 (mixed- frequency jitter pattern)011= Repeat initial lane alignment (generates a K28.5 character and repeats lane alignment sequences continuously)100= 12-octet RPAT jitter pattern
4	LINKLAY RPAT	R/W	Oh	This bit changes the running disparity in a modified RPAT pattern test mode (only when link layer test mode = 100). 0 = Normal operation 1= Changes disparity
3	LMFCMASK RESET	R/W	0h	0= Normal operation
2	JESDMODE1	R/W	1h	These bits select the configuration register to configure the correct LMFS frame assemblies for different decimation settings; see the JESD frame assembly tables in the <i>Section 8.4.2.2</i> section
1	JESDMODE2	R/W	Oh	These bits select the configuration register to configure the correct LMFS frame assemblies for different decimation settings; see the JESD frame assembly tables in the <i>Section 8.4.2.2</i> section
0	RAMP12BIT	R/W	0h	12-bit RAMP test pattern.0 = Normal data output 1= Digital output is the RAMP pattern

#### 8.5.11.4 Register 004h (address = 004h), JESD Digital Page

#### Figure 8-65. Register 004h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	REL ILA SEQ	
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	

#### Table 8-62. Register 004h Field Descriptions

Bit	Field	Туре	Reset	Description				
7-2	0	W	0h	Must write 0				
1-0	REL ILA SEQ	R/W		These bits delay the generation of the lane alignment sequence by 0, 1, 2, or 3 multiframes after the code group synchronization. 00 = 0 multiframe delays 01 = 1 multiframe delay 10 = 2 multiframe delays 11 = 3 multiframe delays				



#### 8.5.11.5 Register 006h (address = 006h), JESD Digital Page

Figure 8-66. Register 006h								
7 6 5 4 3 2 1 0								
SCRAMBLE EN	SCRAMBLE EN         0 <th< td=""></th<>							
R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	

#### Table 8-63. Register 006h Field Descriptions

Bit	Field	Туре	Reset	Description
7	SCRAMBLE EN	R/W	0h	This bit is the scramble enable bit in the JESD204B interface. 0 = Scrambling disabled 1 = Scrambling enabled
6-0	0	W	0h	Must write 0

#### 8.5.11.6 Register 007h (address = 007h), JESD Digital Page

#### Figure 8-67. Register 007h

7	6	5	4	3	2	1	0
0	0	0		FRAME	S PER MULTIFR	AME (K)	
W-0h	W-0h	W-0h			R/W-0h		

#### Table 8-64. Register 007h Field Descriptions

Bit	Field	Туре	Reset	Description	
7-5	0	W	0h	Must write 0	
4-0	FRAMES PER MULTIFRAME (K)	R/W	0h	These bits set the number of multiframes. Actual K is the value in hex + 1 (that is, 0Fh is K = 16).	

#### 8.5.11.7 Register 016h (address = 016h), JESD Digital Page

#### Figure 8-68. Register 016h

				0			
7	6	5	4	3	2	1	0
0	40x MODE			0	0	0	0
W-0h	R/W-0h			W-0h	W-0h	W-0h	W-0h

#### Table 8-65. Register 016h Field Descriptions

Bit	Field	Туре	Reset	Description		
7	0	W 0h		Must write 0		
6-4	40X MODE	R/W		This register must be set for 40x mode operation. 000 = Register is set for 20x and 80x mode 111 = Register must be set for 40x mode		
3-0	0	W	0h	Must write 0		



#### 8.5.11.8 Register 017h (address = 017h), JESD Digital Page

	Figure 8-69. Register 017h											
7	7 6 5 4 3 2 1 0											
0	0	0	0 0 Lane0 PC		Lane1 POL	Lane2 POL	Lane3 POL					
W-0	h R/W-0h	R/W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h					

#### Table 8-66. Register 017h Field Descriptions

Bit	Bit Field Type Reset Description			
7	0	W         0h         Must write 0           R/W         0h         Must write 0		Must write 0
6-4	0			Must write 0
3-0	Lane[3:0] POL	W	0h	These bits set the polarity of the individual JESD output lanes. 0 = Polarity as given in the pinout (noninverted) 1 = Inverts polarity (positive, P, or negative, M)

#### 8.5.11.9 Register 032h-035h (address = 032h-035h), JESD Digital Page

#### Figure 8-70. Register 032h

7	6	5	4	3	2	1	0
		0	0				
	W-0h	W-0h					

Figure	8-71.	Register	033h
--------	-------	----------	------

7	6	5	4	3	2	1	0		
	SEL EMP LANE 1								
	W-0h	W-0h							

#### Figure 8-72. Register 034h

7	6	5	4	3	2	1	0		
	SEL EMP LANE 2								
	W-0h	W-0h							

#### Figure 8-73. Register 035h

7	6	5	4	3	2	1	0		
	SEL EMP LANE 3								
	R/W-0h								

#### Table 8-67. Register 032h-035h Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	SEL EMP LANE	R/W		These bits select the amount of de-emphasis for the JESD output transmitter. The de-emphasis value in dB is measured as the ratio between the peak value after the signal transition to the settled value of the voltage in one bit period. 0 = 0  dB 1 = -1  dB 3 = -2  dB 7 = -4.1  dB 15 = -6.2  dB 31 = -8.2  dB 63 = -11.5  dB
1-0	0	W	0h	Must write 0

#### 8.5.11.10 Register 036h (address = 036h), JESD Digital Page

Figure 8-74. Register 036h								
7	6	5	4	3	2	1	0	

96 Submit Document Feedback

Copyright © 2021 Texas Instruments Incorporated



	Fi	igure 8-74. F	Register 036	h (continue	d)			
0	CMOS SYNCB	0	0	0	0	0	0	
W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	

#### Table 8-68. Register 036h Field Descriptions

<u>v</u> · · · · · · · · · · · · · · · · · · ·										
Bit	Field	Id Type Reset Description		Description						
7	0	W	0h	Must write 0						
6	CMOS SYNCB	R/W		This bit enables single-ended control of SYNCB using the GPIO4 pin (pin 63). The differential SYNCB input is ignored. Set the EN CMOS SYNCB bit and keep the CH bit high to make this bit effective. 0 = Differential SYNCB input 1 = Single-ended SYNCB input using pin 63						
5-0	0	W	0h	Must write 0						

#### 8.5.11.11 Register 037h (address = 037h), JESD Digital Page

#### Figure 8-75. Register 037h

			•	U			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	PLL M	ODE
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-	-0h

#### Table 8-69. Register 037h Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	0	W	0h	Must write 0
1-0	PLL MODE	R/W	0h	These bits select the PLL multiplication factor; see the JESD tables in the <i>Section 8.4.2.2</i> section for settings. 00 = 20x mode 01 = 16x mode 10 = 40x mode (the 40x MODE bit in register 16h must also be set) 11 = 80x mode



#### 8.5.11.12 Register 03Ch (address = 03Ch), JESD Digital Page

	Figure 8-76. Register 03Ch								
7	6	5	4	3	2	1	0		
0	0	0	0	0	0	0	EN CMOS SYNCB		
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h		

#### Table 8-70. Register 03Ch Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	EN CMOS SYNCB	R/W	Oh	<ul> <li>Set this bit and the CMOS SYNCB bit high to provide a single- ended SYNC input to the device instead of differential. Also, keep the CH bit high. Thus:</li> <li>Select the JESD digital page.</li> <li>Write address 7036h with value 40h.</li> <li>Write address 703Ch with value 01h.</li> </ul>

#### 8.5.11.13 Register 03Eh (address = 03Eh), JESD Digital Page

#### Figure 8-77. Register 03Eh

7	6	5	4	3	2	1	0
0	MASK CLKDIV SYSREF	MASK NCO SYSREF	0	0	0	0	0
W-0h	R/W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h

#### Table 8-71. Register 03Eh Field Descriptions

Bit	Bit Field		Reset	Description						
7	0	W	0h	Must write 0						
6	MASK CLKDIV SYSREF	R/W	0h	Use this bit to mask the SYSREF going to the input clock divider. 0 = Input clock divider is reset when SYSREF is asserted (that is, when SYSREF transitions from low to high) 1 = Input clock divider ignores SYSREF assertions						
5	MASK NCO SYSREF	R/W	0h	Use this bit to mask the SYSREF going to the NCO in the DDC block and LMFC counter of the JESD interface. 0 = NCO phase and LMFC counter are reset when SYSREF is asserted (that is, when SYSREF transitions from low to high) 1 = NCO and LMFC counter ignore SYSREF assertions						
4-0	0	W	0h	Must write 0						



#### 8.5.12 Decimation Filter Page

#### Direct Addressing, 16-Bit Address, 5000h for Channel A, 5800h for Channel B

#### 8.5.12.1 Register 000h (address = 000h), Decimation Filter Page

Figure 8-78. Register 000h									
7	6	5	4	3	2	1	0		
0	0	0	0	0	0	0	DDC EN		
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h		

#### Table 8-72. Register 000h Field Descriptions

Bit	Field	Туре	pe Reset Description								
7-1	0	W	0h Must write 0								
0	DDC EN	R/W	0h	This bit enables the decimation filter and disables the bypass mode. 0 = Do not use 1 = Decimation filter enabled							

#### 8.5.12.2 Register 001h (address = 001h), Decimation Filter Page

#### Figure 8-79. Register 001h

7	6	5	4	3	2	1	0
0	0	0	0		DECIM F	ACTOR	
W-0h	W-0h	W-0h	W-0h		R/W	/-0h	

#### Table 8-73. Register 001h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	W	0h	Must write 0
3-0	DECIM FACTOR	R/W	Oh	These bits configure the decimation filter setting. 0000 = Divide-by-4 complex 0001 = Divide-by-6 complex 0010 = Divide-by-8 complex 0011 = Divide-by-9 complex 0100 = Divide-by-10 complex 0101 = Divide-by-12 complex 0101 = Divide-by-12 complex 0111 = Divide-by-16 complex 1000 = Divide-by-18 complex 1001 = Divide-by-20 complex 1010 = Divide-by-24 complex 1011 = Not used 1100 = Divide-by-32 complex



#### 8.5.12.3 Register 002h (address = 2h), Decimation Filter Page

	Figure 8-80. Register 002h											
7	6	5	4	3	2	1	0					
0	0 0 0 0 0 0 0 0 DUAL BAND EN											
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h					

#### Table 8-74. Register 002h Field Descriptions

				•
Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	DUAL BAND EN	R/W	0h	This bit enables the dual-band DDC filter for the corresponding channel. 0 = Single-band DDC; available in both ADC32RF80 and ADC32RF83 1 = Dual-band DDC; available in ADC32RF80 only

#### 8.5.12.4 Register 005h (address = 005h), Decimation Filter Page

			Figure 8-81. I	Register 005h			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	REAL OUT EN
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

#### Table 8-75. Register 005h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	REAL OUT EN	R/W	0h	This bit converts the complex output to real output at 2x the output rate. 0 = Complex output format 1 = Real output format

#### 8.5.12.5 Register 006h (address = 006h), Decimation Filter Page

#### Figure 8-82. Register 006h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	DDC MUX
W-0h	R/W-0h						

#### Table 8-76. Register 006h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	DDC MUX	R/W		This bit connects the DDC to the alternate channel ADC to enable up to four DDCs with one ADC and completely turn off the other ADC channel. 0 = Normal operation 1 = DDC block takes input from the alternate ADC



7

0

#### 8.5.12.6 Register 007h (address = 007h), Decimation Filter Page

	Figure 8-83. Register 007h										
7	7 6 5 4 3 2 1 0										
	DDC0 NCO1 LSB										
	R/W-0h										

#### Table 8-77. Register 007h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DDC0 NCO1 LSB	R/W		These bits are the LSB of the NCO frequency word for NCO1 of DDC0 (band 1). The LSB represents $f_S / (2^{16})$ , where $f_S$ is the ADC sampling frequency.

#### 8.5.12.7 Register 008h (address = 008h), Decimation Filter Page

# Figure 8-84. Register 008h 6 5 4 3 2 1 DDC0 NC01 MSB

DDC0 NCO1 MSB
R/W-0h

#### Table 8-78. Register 008h Field Descriptions

				•
Bit	Field	Туре	Reset	Description
7-0	DDC0 NCO1 MSB	R/W	0h	These bits are the MSB of the NCO frequency word for NCO1 of DDC0 (band 1). The LSB represents $f_S$ / (2 <sup>16</sup> ), where $f_S$ is the ADC sampling frequency.

#### 8.5.12.8 Register 009h (address = 009h), Decimation Filter Page

#### Figure 8-85. Register 009h

7	6	5	4	3	2	1	0
			DDC0 N	CO2 LSB			
			R/W	/-0h			

#### Table 8-79. Register 009h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DDC0 NCO2 MSB	R/W		These bits are the LSB of the NCO frequency word for NCO2 of DDC0 (band 1). The LSB represents $f_S$ / (2 <sup>16</sup> ), where $f_S$ is the ADC sampling frequency.



#### 8.5.12.9 Register 00Ah (address = 00Ah), Decimation Filter Page

Figure	8-86.	Register	00Ah
--------	-------	----------	------

7	6	5	4	3	2	1	0			
	DDC0 NCO2 MSB									
R/W-0h										

#### Table 8-80. Register 00Ah Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DDC0 NCO2 MSB	R/W		These bits are the MSB of the NCO frequency word for NCO2 of DDC0 (band 1). The LSB represents $f_S$ / (2 <sup>16</sup> ), where $f_S$ is the ADC sampling frequency.

#### 8.5.12.10 Register 00Bh (address = 00Bh), Decimation Filter Page

Figure 8-87. Register 00Bh										
7 6 5 4 3 2 1 0										
			DDC0 N	CO3 LSB						
	R/W-0h									

#### Table 8-81. Register 00Bh Field Descriptions

Bit	Field	Туре	Reset	Description		
7-0	DDC0 NCO3 LSB	R/W	Oh	These bits are the LSB of the NCO frequency word for NCO3 of DDC0 (band 1). The LSB represents $f_S$ / (2 <sup>16</sup> ), where $f_S$ is the ADC sampling frequency.		

#### 8.5.12.11 Register 00Ch (address = 00Ch), Decimation Filter Page

#### Figure 8-88. Register 00Ch

7	6	5	4	3	2	1	0			
	DDC0 NCO3 MSB									
	R/W-0h									

#### Table 8-82. Register 00Ch Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DDC0 NCO3 MSB	R/W		These bits are the MSB of the NCO frequency word for NCO3 of DDC0 (band 1). The LSB represents $f_S$ / (2 <sup>16</sup> ), where $f_S$ is the ADC sampling frequency.



#### 8.5.12.12 Register 00Dh (address = 00Dh), Decimation Filter Page

Figure 8-89. Register 00Dh										
7 6 5 4 3 2 1 0										
	DDC1 NCO4 LSB									
R/W-0h										

#### Table 8-83. Register 00Dh Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DDC1 NCO4 LSB	R/W		These bits are the LSB of the NCO frequency word for NCO4 of DDC1 (band 2, only when dual-band mode is enabled). The LSB represents $f_S / (2^{16})$ , where $f_S$ is the ADC sampling frequency.

#### 8.5.12.13 Register 00Eh (address = 00Eh), Decimation Filter Page

Figure 8-90. Register 00Eh										
7 6 5 4 3 2 1 0										
			DDC1 N	CO4 MSB						
R/W-0h										

#### Table 8-84. Register 00Eh Field Descriptions

		U					
Bit	Field	Туре	Reset	Description			
7-0	DDC1 NCO4 MSB	R/W		These bits are the MSB of the NCO frequency word for NCO4 of DDC1 (band 2, only when dual-band mode is enabled). The LSB represents $f_S / (2^{16})$ , where $f_S$ is the ADC sampling frequency.			

#### 8.5.12.14 Register 00Fh (address = 00Fh), Decimation Filter Page

#### Figure 8-91. Register 00Fh

				<u> </u>			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	NCO SEL PIN
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

#### Table 8-85. Register 00Fh Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	NCO SEL PIN	R/W	0h	This bit enables NCO selection through the GPIO pins. 0 = NCO selection through SPI (see address 0h10) 1 = NCO selection through GPIO pins

#### 8.5.12.15 Register 010h (address = 010h), Decimation Filter Page

			Figure 8-92. F	Register 010h			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	NCO	SEL
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W	/-0h

#### Table 8-86. Register 010h Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	0	W	0h	Must write 0
1-0	NCO SEL	R/W		These bits enable NCO selection through register setting. 00 = NCO1 selected for DDC 1 01 = NCO2 selected for DDC 1 10 = NCO3 selected for DDC 1

#### 8.5.12.16 Register 011h (address = 011h), Decimation Filter Page

	Figure 8-93. Register 011h							
7	6	5	4	3	2	1	0	
0	0	0	0	0	0	LMFC RES	SET MODE	
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W	/-0h	

#### Table 8-87. Register 011h Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	0	W	0h	Must write 0
1-0	LMFC RESET MODE	R/W	Oh	These bits reset the configuration for all DDCs and NCOs. 00 = All DDCs and NCOs are reset with every LMFC RESET 01 = Reset with first LMFC RESET after DDC start. Afterwards, reset only when analog clock dividers are resynchronized. 10 = Reset with first LMFC RESET after DDC start. Afterwards, whenever analog clock dividers are resynchronized, use two LMFC resets. 11 = Do not use an LMFC reset at all. Reset the DDCs only when a DDC start is asserted and afterwards continue normal operation. Deterministic latency is not ensured.

#### 8.5.12.17 Register 014h (address = 014h), Decimation Filter Page

#### Figure 8-94. Register 014h

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	DDC0 6DB GAIN
W-0h	R/W-0h						

#### Table 8-88. Register 014h Field Descriptions

Bit	Field	Туре	Reset	Description					
7-1	0	W	0h	Must write 0					
0	DDC0 6DB GAIN	R/W		This bit scales the output of DDC0 by 2 (6 dB) to compensate for real-to-complex conversion and image suppression. This scaling does not apply to the high-bandwidth filter path (divide- by-4 and -6); see register 1Fh. 0 = Normal operation 1 = 6-dB digital gain is added					

#### 8.5.12.18 Register 016h (address = 016h), Decimation Filter Page

			Figure	8-95. Regist	er 016h		
7	6	5	4	3	2	1	0

104 Submit Document Feedback

Copyright © 2021 Texas Instruments Incorporated



	Figure 8-95. Register 016h (continued)								
0	0	0	0	0	0	0	DDC1 6DB GAIN		
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h		

#### Table 8-89. Register 016h Field Descriptions

Bit	Field	Туре	Reset	Description				
7-1	0	W	0h	Must write 0				
0	DDC1 6DB GAIN	R/W	0h	This bit scales the output of DDC1 by 2 (6 dB) to compensate for real-to-complex conversion and image suppression. This scaling does not apply to the high-bandwidth filter path (divide- by-4 and -6); see register 1Fh. 0 = Normal operation 1 = 6-dB digital gain is added				

#### 8.5.12.19 Register 01Eh (address = 01Eh), Decimation Filter Page

#### Figure 8-96. Register 01Eh

7	6 5 4		4	3	2	1	0
0		DDC DET LAT		0	0	0	0
W-0h	R/W-5h			W-1h	W-1h	W-1h	W-1h

#### Table 8-90. Register 01Eh Field Descriptions

Bit	Field	Туре	Reset	Description
7	0	W	0h	Must write 0
6-4	DDC DET LAT	R/W		These bits ensure deterministic latency depending on the decimation setting used; see Table 8-91.
3-0	0	W	1h	Must write 0

#### Table 8-91. DDC DET LAT Bit Settings

SETTING	COMPLEX DECIMATION SETTING
10h	Divide-by-24, -32 complex
20h	Divide-by-16, -18, -20 complex
40h	Divide-by-by 6, -12 complex
50h	Divide-by-4, -8, -9, -10 complex



#### 8.5.12.20 Register 01Fh (address = 01Fh), Decimation Filter Page

Figure 8-97. Register 01Fh									
7	6	5	4	3	2	1	0		
0	0	0	0	0	0	0	WBF 6DB GAIN		
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h		

#### Table 8-92. Register 01Fh Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	WBF 6DB GAIN	R/W	Oh	This bit scales the output of the wide bandwidth DDC filter by 2 (6 dB) to compensate for real-to-complex conversion and image suppression. This setting only applies to the high-bandwidth filter path (divide-by-4 and -6). 0 = Normal operation 1 = 6-dB digital gain is added

#### 8.5.12.21 Register 033h-036h (address = 033h-036h), Decimation Filter Page

## Figure 8-98. Register 033h

7	6	5	4	3	2	1	0		
CUSTOM PATTERN1[7:0]									
	R/W-0h								

	Figure 8-99. Register 034h									
	7	6	5	4	3	2	1	0		
ĺ	CUSTOM PATTERN1[15:8]									
				R/V	V-0h					

Figure 8-100. Register 035h									
7 6 5 4 3 2 1 0									
	CUSTOM PATTERN2[7:0]								
			R/V	V-0h					

#### Figure 8-101. Register 036h

7	7 6 5 4				3 2 1 0				
CUSTOM PATTERN2[15:8]									
R/W-0h									

#### Table 8-93. Register 033h-036h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	CUSTOM PATTERN	R/W	0h	These bits set the custom test pattern in address 33h, 34h, 35h, or 36h.



#### 8.5.12.22 Register 037h (address = 037h), Decimation Filter Page

Figure 8-102. Register 037h								
7	6	5	4	3	2	1	0	
	TEST PATTERN	DDC1 Q-DATA			TEST PATTERN	I DDC1 I-DATA		
W-0h	W-0h	W-0h	W-0h		R/W	-0h		

#### Table 8-94. Register 037h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	TEST PATTERN DDC1 Q-DATA	w	Oh	These bits select the test patten for the Q stream of the DDC1. 0000 = Normal operation using ADC output data 0001 = Outputs all 0s 0010 = Outputs all 1s 0011 = Outputs toggle pattern: output data are an alternating sequence of 101010101010 and 01010101010101 0100 = Output digital ramp: output data increment by one LSB every clock cycle from code 0 to 65535 0110 = Single pattern: output data are a custom pattern 1 (75h and 76h) 0111 Double pattern: output data alternate between custom pattern 1 and custom pattern 2 1000 = Deskew pattern: output data are FFFh
3-0	TEST PATTERN DDC1 I-DATA	R/W	Oh	These bits select the test patten for the I stream of the DDC1. 0000 = Normal operation using ADC output data 0001 = Outputs all 0s 0010 = Outputs all 1s 0011 = Outputs toggle pattern: output data are an alternating sequence of 10101010101010 and 01010101010101 0100 = Output digital ramp: output data increment by one LSB every clock cycle from code 0 to 65535 0110 = Single pattern: output data are a custom pattern 1 (75h and 76h) 0111 Double pattern: output data alternate between custom pattern 1 and custom pattern 2 1000 = Deskew pattern: output data are FFFh



#### 8.5.12.22.1 Register 038h (address = 038h), Decimation Filter Page

#### Figure 8-103. Register 038h

7	6	5	4	3	2	1	0
	TEST PATTERN	DDC2 Q-DATA		TEST PATTERN DDC2 I -DATA			
R/W-0h					R/W	/-0h	

#### Table 8-95. Register 038h Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	TEST PATTERN DDC2 Q-DATA	w	Oh	These bits select the test patten for the Q stream of the DDC2. 0000 = Normal operation using ADC output data 0001 = Outputs all 0s 0010 = Outputs all 1s 0011 = Outputs toggle pattern: output data are an alternating sequence of 10101010101010 and 01010101010101 0100 = Output digital ramp: output data increment by one LSB every clock cycle from code 0 to 65535 0110 = Single pattern: output data are a custom pattern 1 (75h and 76h) 0111 Double pattern: output data alternate between custom pattern 1 and custom pattern 2 1000 = Deskew pattern: output data are FFFh
3-0	TEST PATTERN DDC2 I -DATA	R/W	Oh	These bits select the test patten for the I stream of the DDC2. 0000 = Normal operation using ADC output data 0001 = Outputs all 0s 0010 = Outputs all 1s 0011 = Outputs toggle pattern: output data are an alternating sequence of 101010101010 and 01010101010101 0100 = Output digital ramp: output data increment by one LSB every clock cycle from code 0 to 65535 0110 = Single pattern: output data are a custom pattern 1 (75h and 76h) 0111 Double pattern: output data alternate between custom pattern 1 and custom pattern 2 1000 = Deskew pattern: output data are FFFh


#### 8.5.12.22.2 Register 039h (address = 039h), Decimation Filter Page

Figure 8-104. Register 039h										
7	6	5	4	3	2	1	0			
0	0	0	0	0	0	0	USE COMMON TEST PATTERN			
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h			

#### Table 8-96. Register 039h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	USE COMMON TEST PATTERN	R/W		<ul> <li>0 = Each data stream sends test patterns programmed by bits[3:0] of register 37h.</li> <li>1 = Test patterns are individually programmed for the I and Q stream of each DDC using the TEST PATTERN DDCx y-DATA register bits (where x = 1 or 2 and y = I or Q).</li> </ul>

#### 8.5.12.23 Register 03Ah (address = 03Ah), Decimation Filter Page

#### Figure 8-105. Register 03Ah

7	6	5	4	3	2	1	0
0	0	0	0	0	0	TEST PAT RES	TP RES EN
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h

#### Table 8-97. Register 03Ah Field Descriptions

Bit	Field	eld Type Reset		Description
7-2	0	W Oh		Must write 0
1	TEST PAT RES	R/W	0h	Pulsing this bit resets the test pattern. The test pattern reset must be enabled first (bit D0). 0 = Normal operation 1 = Reset the test pattern
0	TP RES EN	R/W	0h	This bit enables the test pattern reset. 0 = Reset disabled 1 = Reset enabled



### 8.5.13 Power Detector Page

#### 8.5.13.1 Register 000h (address = 000h), Power Detector Page

Figure	8-106	Register	000h
riguic	0-100.	Register	00011

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	PKDET EN
W-0h	R/W-0h						

#### Table 8-98. Register 000h Field Descriptions

Bit	Field Type F		Reset	Description
7-1	0	W	0h	Must write 0
0	PKDET EN	R/W	0h	This bit enables the peak power and crossing detector. 0 = Power detector disabled 1 = Power detector enabled

### 8.5.13.2 Register 001h-002h (address = 001h-002h), Power Detector Page

	Figure 8-107. Register 001h									
7 6 5 4 3 2 1 0										
			BLKPKE	DET [7:0]						
			R/W	/-0h						

#### Figure 8-108. Register 002h

7	6	5	4	3	2	1	0		
	BLKPKDET [15:8]								
	R/W-0h								

#### Table 8-99. Register 001h-002h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	BLKPKDET	R/W	0h	This register specifies the block length in terms of number of samples (S') used for peak power computation. Each sample S' is a peak of 8 actual ADC samples. This parameter is a 17-bit value directly in linear scale. In decimation mode, the block length must be a multiple of a divide-by-4 or -6 complex: length = $5 \times$ decimation factor. The divide-by-8 to -32 complex: length = $10 \times$ decimation factor.



#### 8.5.13.3 Register 003h (address = 003h), Power Detector Page

	Figure 8-109. Register 003h								
7	6	5	4	3	2	1	0		
0	0	0	0	0	0	0	BLKPKDET[16]		
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h		

#### Table 8-100. Register 003h Field Descriptions

Bit	Field	Туре	Reset	Description				
7-1	0	W	0h	Must write 0				
0	BLKPKDET[16]	R/W		This register specifies the block length in terms of number of samples (S') used for peak power computation. Each sample S' is a peak of 8 actual ADC samples. This parameter is a 17-bit value directly in linear scale. In decimation mode, the block length must be a multiple of a divide-by-4 or -6 complex: length = $5 \times$ decimation factor. The divide-by-8 to -32 complex: length = $10 \times$ decimation factor.				

#### 8.5.13.4 Register 007h-00Ah (address = 007h-00Ah), Power Detector Page

#### Figure 8-110. Register 007h

7	6	5	4	3	2	1	0		
	BLKTHHH								
			R/W-0h						

#### Figure 8-111. Register 008h

7	6	5	4	3	2	1	0
	BLKTHHL						
	R/W-0h						

	Figure 8-112. Register 009h								
7	6	5	4	3	2	1	0		
			BLK	THLH					
			R/V	V-0h					

#### Figure 8-113. Register 00Ah

7	6	5	4	3	2	1	0
BLKTHLL							
R/W-0h							

#### Table 8-101. Register 007h-00Ah Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	BLKTHHH BLKTHHL BLKTHLH BLKTHLL	R/W		These registers set the four different thresholds for the hysteresis function threshold values from 0 to 256 (2TH), where 256 is equivalent to the peak amplitude. Example: BLKTHHH is set to $-2 \text{ dBFS}$ from peak: $10^{(-2/20) \times 256}$ = 203, then set 5407h, 5C07h = CBh.



### 8.5.13.5 Register 00Bh-00Ch (address = 00Bh-00Ch), Power Detector Page

Figure 8-114. Register 00Bh								
7	6	5	4	3	2	1	0	
DWELL[7:0]								
			R/V	V-0h				
		F		Register AAC	'n			

			-igure 8-115.	Register 00Cr	ו		
7	6	5	4	3	2	1	0
			DWEL	L[15:8]			

R/W-0h

#### Table 8-102. Register 00Bh-00Ch Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DWELL	R/W	Oh	DWELL time counter. When the computed block peak crosses the upper thresholds BLKTHHH or BLKTHLH, the peak detector output flags are set. In order to be reset, the computed block peak must remain continuously lower than the lower threshold (BLKTHLL or BLKTHLL) for the period specified by the DWELL value. This threshold is 16 bits, is specified in terms of $f_S / 8$ clock cycles, and must be set to 0 for the crossing detector. Example: if $f_S = 3$ GSPS, $f_S / 8 = 375$ MHz, and DWELL = 0100h then the DWELL time = $2^9 / 375$ MHz = 1.36 µs.

#### 8.5.13.6 Register 00Dh (address = 00Dh), Power Detector Page

#### Figure 8-116. Register 00Dh

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	FILT0LPSEL
W-0h	R/W-0h						

#### Table 8-103. Register 00Dh Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	FILTOLPSEL	R/W		This bit selects either the block detector output or 2-bit output as the input to the IIR filter. 0 = Use the output of the high comparators (HH and HL) as the input of the IIR filter 1 = Combine the output of the high (HH and HL) and low (LH and LL) comparators to generate a 3-level input to the IIR filter (-1, 0, 1)



#### 8.5.13.7 Register 00Eh (address = 00Eh), Power Detector Page

Figure 8-117. Register 00Eh							
7	6	5	4	3	2	1	0
0	0	0	0		TIMEC	ONST	
W-0h	W-0h	W-0h	W-0h		R/W	-0h	

#### Table 8-104. Register 00Eh Field Descriptions

Bit	Field	Туре	Reset	Description				
7-4	0	W	0h	Must write 0				
3-0	TIMECONST	R/W		These bits set the crossing detector time period for N = 0 to 15 as $2^{N} \times f_{S} / 8$ clock cycles. The maximum time period is 32768 × $f_{S} / 8$ clock cycles (approximately 87 µs at 3 GSPS).				

# 8.5.13.8 Register 00Fh, 010h-012h, and 016h-019h (address = 00Fh, 010h-012h, and 016h-019h), Power Detector Page

Figure 8-118. Register 00Fh									
7 6 5 4 3 2 1 0									
			FILOTH	HH[7:0]					
	R/W-0h								

	Figure 8-119. Register 010h											
7 6 5 4 3 2 1 0												
FILOTHH[15:8]												
	R/W-0h											

Figure 8-120. Register 011h										
7 6 5 4 3 2 1 0										
			FILOTI	HL[7:0]						
	R/W-0h									

	Figure 8-121. Register 012h										
7 6 5 4 3 2 1											
			FIL0TH	IL[15:8]							
			R/W	/-0h							

Figure 8-122. Regi	ister 016h	
--------------------	------------	--

7	6	5	4	3	2	1	0			
	FIL1THH[7:0]									
R/W-0h										

#### Figure 8-123. Register 017h

	7	6	5	4	3	2	1	0		
FIL1THH[15:8]										
	R/W-0h									

#### Figure 8-124. Register 018h

7	6	5	4	3	2	1	0		
FIL1THL[7:0]									
	R/W-0h								



Figure 8-125. Register 019h										
7 6 5 4 3 2 1										
			FIL1TH	HL[15:8]						
	R/W-0h									

Та	Table 8-105. Register 00Fh, 010h, 011h, 012h, 016h, 017h, 018h, and 019h Field Descriptions									
Bit	Field	Туре	Reset Description							
7-0	FILOTHH FILOTHL FIL1THH FIL1THL	R/W	0h	Comparison thresholds for the crossing detector counter. This threshold is 16 bits in 2.14 signed notation. A value of 1 (4000h) corresponds to 100% crossings, a value of 0.125 (0800h) corresponds to 12.5% crossings.						

### 8.5.13.9 Register 013h-01Ah (address = 013h-01Ah), Power Detector Page

	Figure 8-126. Register 013h									
7	6	5	4	3	2	1	0			
0	0	0	0	0	0	0	IIR0 2BIT EN			
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h			

Figure 8-127. Register 01Ah										
7	6	5	4	3	2	1	0			
0	0	0	0	0	0	0	IIR1 2BIT EN			
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h			

#### Table 8-106. Register 013h and 01Ah Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	IIR0 2BIT EN IIR1 2BIT EN	R/W		This bit enables 2-bit output format of the IIR0 and IIR1 output comparators. 0 = Selects 1-bit output format 1 = Selects 2-bit output format



#### 8.5.13.10 Register 01Dh-01Eh (address = 01Dh-01Eh), Power Detector Page

Figure 8-128. Register 01Dh										
7	6	5	4	3	2	1	0			
DWELLIIR[7:0]										
R/W-0h										
Figure 8-129 Register 01Eh										

Figure 8-129. Register 01En										
7	6	5	4	3	2	1	0			
DWELLIIR[15:8]										
			R/W	/-0h						

#### Table 8-107. Register 01Dh-01Eh Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	DWELLIIR	R/W		DWELL time counter for the IIR output comparators. When the IIR filter output crosses the upper thresholds FIL0THH or FIL1THH, the IIR peak detector output flags are set. In order to be reset, the output of the IIR filter must remain continuously lower than the lower threshold (FIL0THL or FIL1THL) for the period specified by the DWELLIIR value. This threshold is 16 bits and is specified in terms of $f_S / 8$ clock cycles. Example: if $f_S = 3$ GSPS, $f_S / 8 = 375$ MHz, and DWELLIIR = 0100h, then the DWELL time = 29 / 375 MHz = 1.36 µs.

#### 8.5.13.11 Register 020h (address = 020h), Power Detector Page

#### Figure 8-130. Register 020h

			•	U U			
7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	RMSDET EN
W-0h	R/W-0h						

#### Table 8-108. Register 020h Field Descriptions

Bit	Field	Туре	Reset	Description		
7-1	0	W	0h	Must write 0		
0	RMSDET EN	R/W		This bit enables the RMS power detector. 0 = Power detector disabled 1 = Power detector enabled		



#### 8.5.13.12 Register 021h (address = 021h), Power Detector Page

#### Figure 8-131. Register 021h

7	6	5	4	3	2	1	0		
0	0	0	PWRDETACCU						
W-0h	W-0h	W-0h	R/W-0h						

#### Table 8-109. Register 021h Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	W	0h	Must write 0
4-0	PWRDETACCU	R/W	0h	These bits program the block length to be used for RMS power computation. The block length is defined in terms of $f_S / 8$ clocks and can be programmed as 2M, where M = 0 to 16.

### 8.5.13.13 Register 022h-025h (address = 022h-025h), Power Detector Page

Figure 8-132. Register 022h										
7	7 6 5 4 3 2 1 0									
	PWRDETH[7:0]									
R/W-0h										

Figure 8-133. Register 023h										
7 6 5 4 3 2 1 0										
PWRDETH[15:8]										
	R/W-0h									

#### Figure 8-134. Register 024h

7	6	5	4	3	2	1	0			
PWRDETL[7:0]										
	R/W-0h									

#### Figure 8-135. Register 025h

7	6	5	4	3	2	1	0			
PWRDETL[15:8]										
	R/W-0h									

#### Table 8-110. Register 022h-025h Field Descriptions

Bit	Field	Туре	Reset	Description					
7-0	PWRDETH[15:0] PWRDETL[15:0]	R/W		The computed average power is compared against these high and low thresholds. One LSB of the thresholds represents $1/2^{16}$ . Example: if PWRDETH is set to -14 dBFS from peak, $(10^{(-14/20)})^2 \times 2^{16} = 2609$ , then set 5422h, 5423h, 5C22h, 5C23h = 0A31h.					



#### 8.5.13.14 Register 027h (address = 027h), Power Detector Page

		I	Figure 8-136.	Register 027h	า		
7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	RMS 2BIT EN
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

#### Table 8-111. Register 027h Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	W	0h	Must write 0
0	RMS 2BIT EN	R/W	0h	This bit enables 2-bit output format on the RMS output comparators. 0 = Selects 1-bit output format 1 = Selects 2-bit output format

#### 8.5.13.15 Register 02Bh (address = 02Bh), Power Detector Page

#### Figure 8-137. Register 02Bh

7	6	5	4	3	2	1	0
0	0	0	RESET AGC	0	0	0	0
W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h	W-0h

#### Table 8-112. Register 02Bh Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	W	0h	Must write 0
4	RESET AGC	R/W	0h	After configuration, the AGC module must be reset and then brought out of reset to start operation. 0 = Clear AGC reset 1 = Set AGC reset Example: set 542Bh to 10h and then to 00h.
3-0	0	W	0h	Must write 0



#### 8.5.13.16 Register 032h-035h (address = 032h-035h), Power Detector Page

Figure 8-138. Register 032h									
7	7 6 5 4 3 2 1 0								
OUTSEL GPIO4									
	R/W-0h								
	Figure 8-139. Register 033h								

7 6 5 4 3 2 1 0										
	OUTSEL GPIO1									
	R/W-0h									

#### Figure 8-140. Register 034h

7	6	5	4	3	2	1	0		
	OUTSEL GPIO3								
R/W-0h									

Figure 8-141. Register 035h									
7 6 5 4 3 2 1 0									
OUTSEL GPIO2									
			R/W	/-0h					

#### Table 8-113. Register 032h-035h Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	OUTSEL GPI01 OUTSEL GPI02 OUTSEL GPI03 OUTSEL GPI04	R/W		These bits set the function or signal for each GPIO pin. 0 = IIR PK DET0[0] of channel A 1 = IIR PK DET0[1] of channel A (2-bit mode) 2 = IIR PK DET1[0] of channel A 3 = IIR PK DET1[1] of channel A (2-bit mode) 4 = BLKPKDETH of channel A 5 = BLKPKDETL of channel A 6 = PWR Det[0] of channel A 7 = PWR Det[1] of channel A (2-bit mode) 8 = FOVR of channel A 9-17 = Repeat outputs 0-8 but for channel B instead



#### 8.5.13.17 Register 037h (address = 037h), Power Detector Page

Figure 8-142. Register 037h							
7	6	5	4	3	2	1	0
0	0	0	0	IODIR GPIO2	IODIR GPIO3	IODIR GPIO1	IODIR GPIO4
W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h	R/W-0h	R/W-0h

#### Table 8-114. Register 037h Field Descriptions

Bit	Field	Туре	Reset	Description						
7-4	0	W	0h	Must write 0						
3-0	IODIRGPIO[4:1]	R/W	0h	These bits select the output direction for the GPIO[4:1] pins. 0 = Input (for the NCO control) 1 = Output (for the AGC alarm function)						

#### 8.5.13.18 Register 038h (address = 038h), Power Detector Page

#### Figure 8-143. Register 038h

7	6	5	4	3	2	1	0
0	0	INSEL1		0	0	INSEL0	
W-0h	W-0h	R/W	R/W-0h		R/W-0h	R/W	-0h

#### Table 8-115. Register 038h Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	W	0h	Must write 0
5-4	INSEL1	R/W	0h	These bits select which GPIO pin is used for the INSEL1 bit. 00 = GPIO4 01 = GPIO1 10 = GPIO3 11 = GPIO2 Table 8-116 lists the NCO selection, based on the bit settings of the INSEL pins.
3-2	0	W	0h	Must write 0
1-0	INSEL0	R/W	0h	These bits select which GPIO pin is used for the INSEL0 bit. 00 = GPIO4 01 = GPIO1 10 = GPIO3 11 = GPIO2 Table 8-116 lists the NCO selection, based on the bit settings of the INSEL pins.

#### Table 8-116. INSEL Bit Settings

	0	
INSEL1	INSEL2	NCO SELECTED
0	0	NCO1
0	1	NCO2
1	0	NCO3
1	1	n/a



### **9** Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

#### 9.1.1 Start-Up Sequence

The steps in Table 9-1 are recommended as the power-up sequence when the ADC32RF8x is in the decimationby-4 complex output mode.

STEP	DESCRIPTION	PAGE, REGISTER ADDRESS AND DATA	COMMENT		
1	Supply all supply voltages. There is no required power-supply sequence for the 1.15 V, 1.2 V, and 1.9 V supplies, and can be supplied in any order.		_		
2	Provide the SYSREF signal.	—	—		
3	Pulse a hardware reset (low-to- high-to-low) on pins 33 and 34.	—	—		
4	Write the register addresses described in the <i>PowerUpConfig</i> file.	Seethe files located in SBAA226	The <i>Power-up config</i> file contains analog trim registers that are required for best performance of the ADC. Write these registers every time after power up.		
5	Write the register addresses mentioned in the ILConfigNyqX_ChA file, where X is the Nyquist zone.	Seethe files located in SBAA226	Based on the signal band of interest, provide the Nyquist zone information to the device.		
6	Write the register addresses mentioned in the ILConfigNyqX_ChB file, where X is the Nyquist zone.	Seethe files located in SBAA226	This step optimizes device' performance by reducing interleaving mismatch errors.		
6.1	Wait for 50 ms for the device to estimate the interleaving errors.	-	-		
7	Depending upon the Nyquist band of operation, choose and write the registers from the appropriate file, <i>NLConfigNyqX_ChA</i> , where X is the Nyquist zone.	Seethe files located in SBAA226	Third-order nonlinearity of the device is optimized by this step for channel A.		
7.1	Depending upon the Nyquist band of operation, choose and write the registers from the appropriate file, <i>NLConfigNyqX_ChB</i> , where X is the Nyquist zone.	Seethe files located in SBAA226	Third-order nonlinearity of the device is optimized by this step for channel B.		
8	Configure the JESD interface and DDC block by writing the registers mentioned in the <i>DDCConfig</i> file.	Seethe files located in SBAA226	Determine the DDC and JESD interface LMFS options. Program these options in this step.		

#### Table 9-1. Initialization Sequence



#### 9.1.2 Hardware Reset

Timing information for the hardware reset is shown in Figure 9-1 and Table 9-2.



Figure 9-1. Hardware Reset Timing Diagram

### Table 9-2. Hardware Reset Timing Information

		MIN	TYP	MAX	UNIT
t <sub>1</sub>	Power-on delay from power-up to active high RESET pulse	1			ms
t <sub>2</sub>	Reset pulse duration: active high RESET pulse duration	1			μs
t <sub>3</sub>	Register write delay from RESET disable to SEN active	100			ns



#### 9.1.3 SNR and Clock Jitter

The signal-to-noise ratio (SNR) of the ADC is limited by three different factors: quantization noise, thermal noise, and jitter, as shown in Equation 5. The quantization noise is typically not noticeable in pipeline converters and is 84 dB for a 14-bit ADC. The thermal noise limits the SNR at low input frequencies and the clock jitter sets the SNR for higher input frequencies.

$$SNRADC[dBc] = -20 \log \sqrt{\left(10^{\frac{SNR_{Quantization Noise}}{20}}\right)^{2} + \left(10^{\frac{SNR_{Thermal Noise}}{20}}\right)^{2} + \left(10^{\frac{SNR_{Jitter}}{20}}\right)^{2}}$$
(5)

The SNR limitation resulting from sample clock jitter can be calculated by Equation 6:

$$SNR_{Jitter} \left[ dBc \right] = -20 \log \left( 2\pi \times f_{IN} \times t_{Jitter} \right)$$
(6)

The total clock jitter ( $T_{Jitter}$ ) has two components: the internal aperture jitter (90  $f_S$ ) is set by the noise of the clock input buffer and the external clock jitter.  $T_{Jitter}$  can be calculated by Equation 7:

$$t_{\text{Jitter}} = \sqrt{\left(t_{\text{Jitter}}, \text{Ext}_{\text{Clock}_{\text{Input}}}\right)^2 + \left(t_{\text{Aperture}_{\text{ADC}}}\right)^2}$$
(7)

External clock jitter can be minimized by using high-quality clock sources and jitter cleaners as well as bandpass filters at the clock input. A faster clock slew rate also improves the ADC aperture jitter.

The ADC32RF8x has a thermal noise of approximately 63 dBFS and an internal aperture jitter of 90 f<sub>S</sub>. The SNR, depending on the amount of external jitter for different input frequencies, is shown in Figure 9-2.



Figure 9-2. ADC SNR vs. Input Frequency and External Clock Jitter



#### 9.1.3.1 External Clock Phase Noise Consideration

External clock jitter can be calculated by integrating the phase noise of the clock source out to approximately two times of the ADC sampling rate  $(2 \times f_S)$ , as shown in Figure 9-3. In order to maximize the ADC SNR, an external band-pass filter is recommended to be used on the clock input. This filter reduces the jitter contribution from the broadband clock phase noise floor by effectively reducing the integration bandwidth to the pass band of the band-pass filter. This method is suitable when estimating the overall ADC SNR resulting from clock jitter at a certain input frequency.



Figure 9-3. Integration Bandwidth for Extracting Jitter from Clock Phase Noise

However, when estimating the affect of a nearby blocker (such as a strong in-band interferer to the sensitivity, the phase noise information can be used directly to estimate the noise budget contribution at a certain offset frequency, as shown in Figure 9-4.



Figure 9-4. Small Wanted Signal in Presence of Interferer

At the sampling instant, the phase noise profile of the clock source convolves with the input signal (for example, the small wanted signal and the strong interferer merge together). If the power of the clock phase noise in the signal band of interest is too large, the wanted signal cannot not be recovered.

The resulting equivalent phase noise at the ADC input is also dependent on the sampling rate of the ADC and frequency of the input signal. The ADC sampling rate scales the clock phase noise, as shown in Equation 8.

$$ADC_{NSD} (dBc / Hz) = PN_{CLK} (dBc / Hz) - 20 \times log \left(\frac{f_{S}}{f_{IN}}\right)$$
(8)

Using this information, the noise contribution resulting from the phase noise profile of the ADC sampling clock can be calculated.



#### 9.1.4 Power Consumption in Different Modes

The ADC32RF8x consumes approximately 6.6 W of power when both channels are active with a divide-by-4 complex output. When different DDC options are used, the power consumption on the DVDD supply changes by a small amount but remains unaffected on other supplies. In the applications requiring just one channel to be active, channel A must be chosen as the active channel and channel B can be powered down. Power consumption reduces to approximately 4 W in single-channel operation with a divide-by-4 option at a 2949.12-MSPS device clock rate.

Table 9-3 shows power consumption in different DDC modes for dual-channel and single-channel operation.

DECIMATION	ACTIVE	ACTIVE DDC	AVDD19 (mA)	AVDD (mA)	OCK Frequency, DVDD (mA)	TOTAL POWER
OPTION	CHANNEL					(mW)
Divide-by-4	Channels A, B	Single	1777	970	1785	6545
Divide-by-8	Channels A, B	Dual	1777	973	1960	6749
Divide-by-8	Channels A, B	Single	1777	973	1730	6485
Divide-by-16	Channels A, B	Dual	1777	972	1971	6761
Divide-by-16	Channels A, B	Single	1777	972	1705	6455
Divide-by-24	Channels A, B	Dual	1771	975	1938	6715
Divide-by-24	Channels A, B	Single	1771	972	1667	6400
Divide-by-32	Channels A, B	Dual	1768	972	1835	6587
Divide-by-32	Channels A, B	Single	1768	970	1574	6285
Divide-by-4	Channel A	Single	961	796	1096	4002
Divide-by-8	Channel A	Dual	961	790	1168	4078
Divide-by-8	Channel A	Single	961	786	1047	3934
Divide-by-16	Channel A	Dual	961	789	1172	4081
Divide-by-16	Channel A	Single	961	786	1045	3932
Divide-by-24	Channel A	Dual	958	785	1155	4051
Divide-by-24	Channel A	Single	958	787	1016	3894
Divide-by-32	Channel A	Dual	956	788	1104	3992
Divide-by-32	Channel A	Single	956	786	978	3845

Table 9.2 Bower Consumption in Different DDC Modes (Sampling Clock Ergusney f. - 2 CSPS)





#### 9.1.5 Using DC Coupling in the ADC32RF8x

The ADC32RF8x can be used in dc-coupling applications. However, the following points must be considered when designing the system:

1. Ensure that the correct common-mode voltage is used at the ADC analog inputs.

The analog inputs are internally self-biased to  $V_{CM}$  through approximately a 33- $\Omega$  resistor. The internal biasing resistors also function as a termination resistor. However, if a different termination is required, the external resistor R<sub>TERM</sub> can be differentially placed between the analog inputs, as shown in Figure 9-5. The amplifier V<sub>OCM</sub> pin is recommended to be driven from the CM pin of the ADC to help the amplifier output common-mode voltage track the required common-mode voltage of the ADC.



Copyright © 2016, Texas Instruments Incorporated

- A. Set the INCR CM IMPEDANCE bit to increase the RCM from 0  $\Omega$  to > 5000  $\Omega$ .
- B.  $R_{DC}$  is approximately 65  $\Omega$ .

#### Figure 9-5. The ADC32RF8x in a DC-Coupling Application

2. Ensure that the correct SPI settings are written to the ADC.

As shown in Figure 9-6, the ADC32RF8x has a digital block that estimates and corrects the offset mismatch among four interleaving ADC cores for a given channel.



Figure 9-6. Offset Corrector in the ADC32RF8x

The offset corrector block nullifies dc,  $f_S / 8$ ,  $f_S / 4$ ,  $3 f_S / 8$ , and  $f_S / 2$ . The resulting spectrum becomes free from static spurs at these frequencies. The corrector continuously processes the data coming from the interleaving ADC cores and cannot distinguish if the tone at these frequencies is part of signal or if the tone originated from a mismatch among the interleaving ADC cores. Thus, in applications where the signal is present at these frequencies, the offset corrector block can be bypassed.

Copyright © 2021 Texas Instruments Incorporated



#### 9.1.5.1 Bypassing the Offset Corrector Block

When the offset corrector is bypassed, offset mismatch among interleaving ADC cores appears in the ADC output spectrum. To correct the effects of mismatch, place the ADC in an idle channel state (no signal at the ADC inputs) and the corrector must be allowed to run for some time to estimate the mismatch, then the corrector is frozen so that the last estimated value is held. Required register writes are provided in Table 9-4.

STEP	REGISTER WRITE	COMMENT					
STEPS FO	R FREEZING THE CORRECTOR	BLOCK					
1	_	Signal source is turned off. The device detects an idle channel at its input.					
2	—	Wait for at least 0.4 ms for the corrector to estimate the internal offset					
	Address 4001h, value 00h						
	Address 4002h, value 00h	Select Offect Corr Dogo Chennel A					
	Address 4003h, value 00h	Select Offset Corr Page Channel A					
3	Address 4004h, value 61h						
	Address 6068h, value C2h	Freeze the corrector for channel A					
	Address 4003h, value 01h	Select Offset Corr Page Channel B					
	Address 6068h, value C2h	Freeze the corrector for channel B					
4	—	Signal source can now be turned on					
STEPS FO	R BYPASSING THE CORRECTOR	RBLOCK					
	Address 4001h, value 00h						
	Address 4002h, value 00h						
	Address 4003h, value 00h						
1	Address 4004h, value 61h	Select Offset Corr Page Channel A					
	Address 6068h, value 46h	Disable the corrector for channel A					
	Address 4003h, value 01h	Select Offset Corr Page Channel B					
	Address 6068h, value 46h	Disable the corrector for channel B					

#### Table 9-4. Freezing and Bypassing the Offset Corrector Block

#### 9.1.5.1.1 Effect of Temperature

Figure 9-7 and Figure 9-8 show the behavior of  $nf_S$  / 8 tones with respect to temperature when the offset corrector block is frozen or disabled.





### 9.2 Typical Application

The ADC32RF8x is designed for wideband receiver applications demanding high dynamic range over a large input frequency range. A typical schematic for an ac-coupled receiver is shown in Figure 9-9.

Decoupling capacitors with low ESL are recommended to be placed as close as possible at the pins indicated in Figure 9-9. Additional capacitors can be placed on the remaining power pins.



Copyright © 2016, Texas Instruments Incorporated

#### Figure 9-9. Typical Application Implementation Diagram



#### 9.2.1 Design Requirements

#### 9.2.1.1 Transformer-Coupled Circuits

Typical applications involving transformer-coupled circuits are discussed in this section. To ensure good amplitude and phase balance at the analog inputs, transformers (such as TC1-1-13 and TC1-1-43) can be used from the dc to 1000-MHz range and from the 1000-MHz to 4-GHz range of input frequencies, respectively. When designing the driving circuits, the ADC input impedance (or SDD11) must be considered.

By using the simple drive circuit of Figure 9-10, uniform performance can be obtained over a wide frequency range. The buffers present at the analog inputs of the device help isolate the external drive source from the switching currents of the sampling circuit.



Copyright © 2016, Texas Instruments Incorporated

#### Figure 9-10. Input Drive Circuit

#### 9.2.2 Detailed Design Procedure

For optimum performance, the analog inputs must be driven differentially. This architecture improves commonmode noise immunity and even-order harmonic rejection. A small resistor (5  $\Omega$  to 10  $\Omega$ ) in series with each input pin is recommended to damp out ringing caused by package parasitics, as shown in Figure 9-10.

#### 9.2.3 Application Curves

Figure 9-11 and Figure 9-12 show the typical performance at 100 MHz and 1780 MHz, respectively.





## **10 Power Supply Recommendations**

The DVDD power supply (1.15 V) must be stable before ramping up the AVDD19 supply (1.9 V), as shown in Figure 10-1. The AVDD supply (1.15 V) can come up in any order during the power sequence. The power supplies can ramp up at any rate and there is no hard requirement for the time delay between DVDD (1.15 V) ramping up to AVDD (1.9 V) ramping up (which can be in orders of microseconds but is recommended to be a few milliseconds).



Figure 10-1. Power Sequencing for the ADC32RF8x Family of Devices



## 11 Layout

## **11.1 Layout Guidelines**

The device evaluation module (EVM) layout can be used as a reference layout to obtain the best performance. A layout diagram of the EVM top layer is provided in Figure 11-1. The *ADC32RF45/RF80 EVM Quick Startup Guide* provides a complete layout of the EVM. Some important points to remember during board layout are:

- Analog inputs are located on opposite sides of the device pinout to ensure minimum crosstalk on the package level. To minimize crosstalk onboard, the analog inputs must exit the pinout in opposite directions, as shown in the reference layout of Figure 11-1 as much as possible.
- In the device pinout, the sampling clock is located on a side perpendicular to the analog inputs in order to minimize coupling. This configuration is also maintained on the reference layout of Figure 11-1 as much as possible.
- Keep digital outputs away from the analog inputs. When these digital outputs exit the pinout, the digital output traces must not be kept parallel to the analog input traces because this configuration can result in coupling from the digital outputs to the analog inputs and degrade performance. All digital output traces to the receiver [such as field-programmable gate arrays (FPGAs) or application-specific integrated circuits (ASICs)] must be matched in length to avoid skew among outputs.
- At each power-supply pin (AVDD, DVDD, or AVDD19), keep a 0.1-μF decoupling capacitor close to the device. A separate decoupling capacitor group consisting of a parallel combination of 10-μF, 1-μF, and 0.1-μF capacitors can be kept close to the supply source.



## 11.2 Layout Example

Figure 11-1. ADC32RF8xEVM Layout



### 12 Device and Documentation Support

#### **12.1 Documentation Support**

#### 12.1.1 Related Documentation

For related documentation see the following:

- ADC32RF45/RF80 EVM Quick Startup Guide
- Configuration Files for the ADC32RF45

#### **12.2 Receiving Notification of Documentation Updates**

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **12.3 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### **12.5 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 12.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
ADC32RF80IRMPR	ACTIVE	VQFN	RMP	72	1500	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF80	Samples
ADC32RF80IRMPT	ACTIVE	VQFN	RMP	72	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF80	Samples
ADC32RF80IRRHR	ACTIVE	VQFN	RRH	72	1500	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF80	Samples
ADC32RF80IRRHT	ACTIVE	VQFN	RRH	72	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF80	Samples
ADC32RF83IRMPR	ACTIVE	VQFN	RMP	72	1500	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF83	Samples
ADC32RF83IRMPT	ACTIVE	VQFN	RMP	72	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF83	Samples
ADC32RF83IRRHR	ACTIVE	VQFN	RRH	72	1500	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF83	Samples
ADC32RF83IRRHT	ACTIVE	VQFN	RRH	72	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ32RF83	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## PACKAGE OPTION ADDENDUM

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



Texas

\*All dimensions are nominal

www.ti.com

## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC32RF80IRMPR	VQFN	RMP	72	1500	330.0	24.4	10.25	10.25	2.25	16.0	24.0	Q2
ADC32RF80IRRHR	VQFN	RRH	72	1500	330.0	24.4	10.25	10.25	2.25	16.0	24.0	Q2
ADC32RF83IRMPR	VQFN	RMP	72	1500	330.0	24.4	10.25	10.25	2.25	16.0	24.0	Q2
ADC32RF83IRRHR	VQFN	RRH	72	1500	330.0	24.4	10.25	10.25	2.25	16.0	24.0	Q2



www.ti.com

## PACKAGE MATERIALS INFORMATION

15-Mar-2023



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC32RF80IRMPR	VQFN	RMP	72	1500	350.0	350.0	43.0
ADC32RF80IRRHR	VQFN	RRH	72	1500	350.0	350.0	43.0
ADC32RF83IRMPR	VQFN	RMP	72	1500	350.0	350.0	43.0
ADC32RF83IRRHR	VQFN	RRH	72	1500	350.0	350.0	43.0

## **RMP0072A**



## **PACKAGE OUTLINE**

## VQFN - 0.9 mm max height

VQFN



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



## **RMP0072A**

## **EXAMPLE BOARD LAYOUT**

### VQFN - 0.9 mm max height

VQFN



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see QFN/SON PCB application report in literature No. SLUA271 (www.ti.com/lit/slua271).



## **RMP0072A**

## **EXAMPLE STENCIL DESIGN**

## VQFN - 0.9 mm max height

VQFN



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



## **RRH0072A**



## **PACKAGE OUTLINE**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



## **RRH0072A**

## **EXAMPLE BOARD LAYOUT**

### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



## **RRH0072A**

## **EXAMPLE STENCIL DESIGN**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2023, Texas Instruments Incorporated